



RF-Emission Test Report

Report No: HR/2020/80004
Applicant: Asiatelco Technologies Inc.
Manufacturer: Asiatelco Technologies Inc.
Product Name: Athena Phone
Model No.(EUT): FR150
Trade Mark: R3Di
FCC ID: 2AXKS-FR150
Standards: ANSI C63.19-2011
CFR 47 FCC Part 20
Date of Receipt: 2020-08-24
Date of Test: 2020-08-26 to 2020-09-01
Date of Issue: 2020-09-23
Test conclusion: **PASS ***

* In the configuration tested, the EUT detailed in this report complied with the standards specified above.

Authorized Signature:

Derek Yang

Wireless Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.



REVISION HISTORY

Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2020-09-23		Original



TEST SUMMARY

Frequency Band	HAC RF Emission Test result*		M-rating
GSM850	E-Field dB(V/m)	36.91	M4
GSM1900	E-Field dB(V/m)	28.02	M4
WCDMA Band II	E-Field dB(V/m)	/	M4
WCDMA Band IV	E-Field dB(V/m)	/	M4
WCDMA Band V	E-Field dB(V/m)	/	M4
CDMA BC0	E-Field dB(V/m)	31.92	M4
CDMA BC1	E-Field dB(V/m)	23.82	M4
CDMA BC10	E-Field dB(V/m)	28.98	M4
LTE Band 2	E-Field dB(V/m)	/	M4
LTE Band 4	E-Field dB(V/m)	/	M4
LTE Band 5	E-Field dB(V/m)	/	M4
LTE Band 12	E-Field dB(V/m)	/	M4
LTE Band 13	E-Field dB(V/m)	/	M4
LTE Band 25	E-Field dB(V/m)	/	M4
LTE Band 26	E-Field dB(V/m)	/	M4
LTE Band 66	E-Field dB(V/m)	/	M4
LTE Band 71	E-Field dB(V/m)	/	M4
LTE Band 41	E-Field dB(V/m)	22.51	M4
WiFi 2.4G	E-Field dB(V/m)	/	M4
HAC Rate Category: M4			

Note:

1) This portable wireless equipment has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std.C63.19-2011 and had been tested in accordance with the specified measurement procedures, Hear-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested and are for North American Bands only.

2) *- HAC RF Emission Test for low power exemption according to ANSI C63.19-2011 and HAC RF Emission rating is M4 (Refer to Section 9.3 for details).

Approved & Released by

Simon Ling

HAC Manager

Tested by

Gavin Gao

HAC Engineer



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1 General Information

1.1 Introduction

The purpose of the Hearing Aid Compatibility is to enable measurements of the near electric fields generated by wireless communication devices in the region controlled for use by a hearing aid in accordance with ANSI-C63.19-2011

The purpose of this standard is to establish categories for hearing aids and for WD (wireless communications devices) that can indicate to health care practitioners and hearing aid users which hearing aids are compatible with which WD, and to provide tests that can be used to assess the electromagnetic characteristics of hearing aids and WD and assign them to these categories. The various parameters required, in order to demonstrate compatibility and accessibility are measured. The design of the standard is such that when a hearing aid and WD achieve one of the categories specified, as measured by the methodology of this standard, the indicated performance is realized.

In order to provide for the usability of a hearing aid with a WD, several factors must be coordinated:

a) Radio frequency (RF) measurements of the near-field electric fields emitted by a WD to categorize these emissions for correlation with the RF immunity of a hearing aid.

Hence, the following are measurements made for the WD:

RF E-Field emissions

The measurement plane is parallel to, and 1.5cm in front of, the reference plane.

Applications for certification of equipment operation under part 20, that a manufacturer is seeking to certify as hearing aid compatible, as set forth in §20.19 of that part, shall include a statement indication compliance with the test requirements of §20.19 and indicating the appropriate U-rating for the equipment. The manufacturer of the equipment shall be responsible for maintaining the test results.

1.2 Details of Client

Applicant:	Asiatelco Technologies Inc.
Address:	4611 Teller Avenue, Suite 110, Newport Beach, CA 92660, USA
Manufacturer:	Asiatelco Technologies Inc.
Address:	4611 Teller Avenue, Suite 110, Newport Beach, CA 92660, USA



1.3 Test Location

Company:	SGS-CSTC Standards Technical Services Co., Ltd. Xi'an Branch
Address:	Single floor D, building 1, Kanghong orange square science and technology park, No.137 keyuan 3rd road, fengdong new town, Xi 'an city, shaanxi China
Post code:	710086
Telephone:	+86 (0) 29 6282 7885
Fax:	+86 (0) 29 6282 7885
E-mail:	ee.xian@sgs.com

1.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **A2LA (Certificate No. 4854.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Xi'an Branch is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 4854.01.

- **FCC –Designation Number: CN1271**

SGS-CSTC Standards Technical Services Co., Ltd., Xi'an Branch has been recognized as an accredited testing laboratory.

Designation Number: CN1271. Test Firm Registration Number: 637380.

- **Innovation, Science and Economic Development Canada**

SGS-CSTC Standards Technical Services Co., Ltd., Xi'an Branch has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0095

ISED#: 25613.



1.5 General Description of EUT

Product Name:	Athena Phone		
Model No.(EUT):	FR150		
Trade Mark:	R3Di		
Device Type :	portable device		
Exposure Category:	uncontrolled environment / general population		
Product Phase:	production unit		
FCC ID:	2AXKS-FR150		
IMEI:	354783970000322/ 354783970000025		
Hardware Version:	B1		
Software Version:	QC28A-FR150-01418_V01-08_07.24.2020_FCC_i-B1		
Antenna Type:	Inner Antenna		
Device Operating Configurations :			
Modulation Mode:	GSM: GMSK, 8PSK; CDMA: QPSK; WCDMA: QPSK; LTE: QPSK,16QAM; WIFI: DSSS, OFDM; BT: GFSK, $\pi/4$ DQPSK,8DPSK;		
Device Class:	B		
GPRS Multi-slots Class:	33	EGPRS Multi-slots Class:	33
HSDPA UE Category:	14	HSUPA UE Category	6
DC-HSDPA UE Category:	24		
Power Class	4,tested with power level 5(GSM850)		
	1,tested with power level 0(GSM1900)		
	3, tested with power control “all up”(CDMA BC0/BC1/BC10)		
	3, tested with power control “all 1”(WCDMA Band II/IV/V)		
	3, tested with power control Max Power(LTE Band 2/4/5/12/13/25/26/66/71/41)		
Frequency Bands:	Band	Tx (MHz)	Rx (MHz)
	GSM850	824~849	869~894
	GSM1900	1850~1910	1930~1990
	WCDMA Band II	1850~1910	1930~1990
	WCDMA Band IV	1710~1755	2110~2155
	WCDMA Band V	824~849	869~894
	CDMA BC0	824~849	869~894
	CDMA BC1	1850~1910	1930~1990
	CDMA BC10	817~824	851~869
	LTE Band 2	1850~1910	1930~1990
	LTE Band 4	1710~1755	2110~2155
	LTE Band 5	824~849	869~894
	LTE Band 12	699~716	729~746
	LTE Band 13	777~787	746~756
	LTE Band 25	1850~1915	1930~1995
	LTE Band 26	814~849	859~894
	LTE Band 66	1710~1780	2110~2180
	LTE Band 71	663~698	617~652
	LTE Band 41	2535~2655	2535~2655
	WIFI 2.4G	2412~2462	2412~2462
	BT	2402~2480	2402~2480
Battery Information:	Model:	BL1438	
	Normal Voltage:	+3.8V	
	Rated capacity:	1600mAh	
	Manufacturer:	ZHONGSHAN TIANMAO BATTERY CO.,LTD.	



1.5.1 DUT Antenna Locations(Back view)

Reference Appendix photos

Note: The Div Ant does not support transmitter function.



1.5.2 List of air interfaces/frequency bands

Air- Interface	Band (MHz)	Type	ANSI C63.19 Tested	Simultaneous Transmitter	Name of Voice Service	Power Reduction
GSM	850	VO	Yes	BT or Wi-Fi	CMRS Voice	NA
	1900					NA
	GPRS/EGPRS	VD	Yes	BT or Wi-Fi	NA	NA
WCDMA	Band II	VO	No ⁽¹⁾	BT or Wi-Fi	CMRS Voice	NA
	Band IV					NA
	Band V					NA
	HSPA	VD	No ⁽¹⁾	BT or Wi-Fi	NA	NA
CDMA	BC0	VO	Yes	BT, Wi-Fi	CMRS Voice	NA
	BC1					NA
	BC10					NA
	EVDO	VD	No ⁽¹⁾	BT or Wi-Fi	NA *	NA
LTE FDD	Band 2	VD	No ⁽¹⁾	BT or Wi-Fi	VoLTE	NA
	Band 4					NA
	Band 5					NA
	Band 12					NA
	Band 13					NA
	Band 25					NA
	Band 26					NA
	Band 66					NA
	Band 71					NA
LTE TDD	Band 41	VD	Yes	BT or Wi-Fi	VoLTE	NA
Wi-Fi	2450	VD	No ⁽¹⁾	WWAN	NA	NA
BT	2450	DT	No	WWAN	NA	NA

VO: Legacy Cellular Voice Service from Table 7.1 in 7.4.2.1 of ANSI C63.19-2011

DT: Digital Transport (no voice)

VD: IP Voice Service over Digital Transport

Remark:

1. The air interface is exempted from testing by low power exemption that its average antenna input power plus its MIF is ≤ 17 dBm and is rated as M4.



1.6 Test Specification

Identity	Document Title
CFR 47 FCC Part 20	§20.19 Hearing aid-compatible mobile handsets.
ANSI C63.19-2011	American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices
KDB 285076 D01	HAC Guidance v05r01
KDB 285076 D03	HAC FAQ v01r02

1.7 ANSI C63.19-2011 limits

Emission Categories	E-field emissions dB(V/m)	
	< 960 MHz	> 960 MHz
Category M1	50-55	40-45
Category M2	45-50	35-40
Category M3	40-45	30-45
Category M4	<40	<30

Table 1: Telephone near-field categories in linear units

2 Calibration certificate

Temperature	Min. = 18°C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%

Table 2: The Ambient Conditions

3 HAC Measurement System

3.1 Measurement System Diagram for SPEAG Robotic

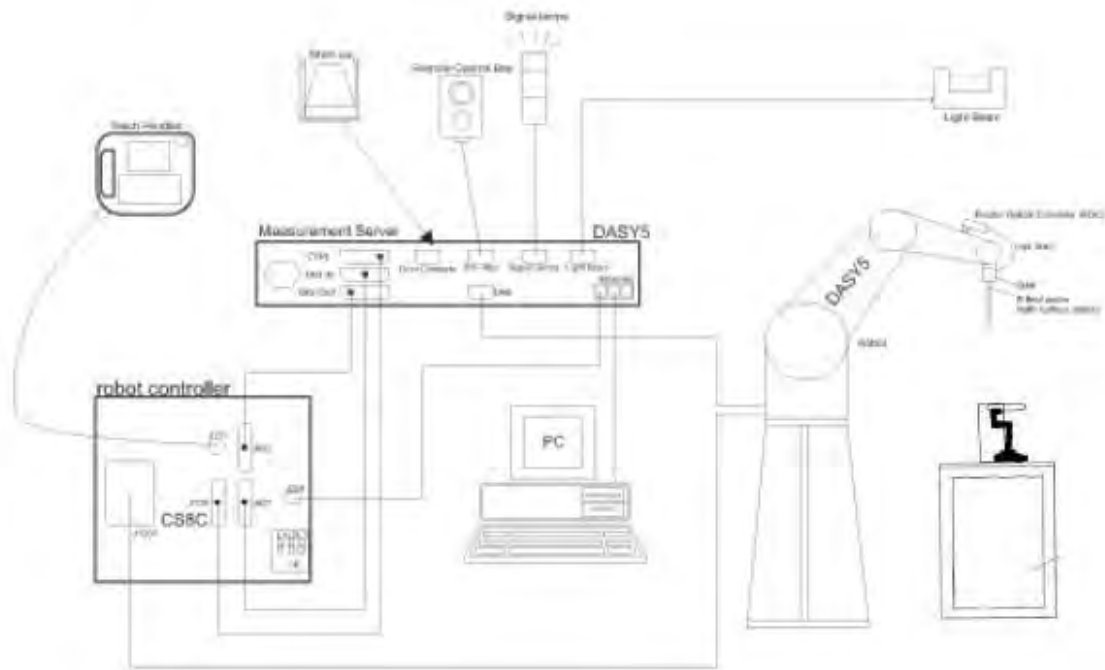


Fig. 1. The SPEAG Robotic Diagram

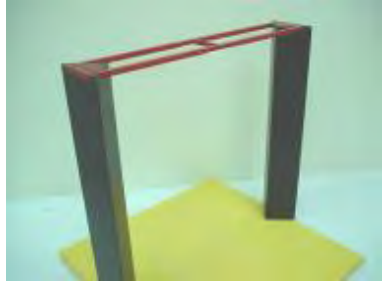
The DASY5 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Stabile RX family) with controller, teach pendant and software. An arm extension is for accommodating the data acquisition electronics (DAE).
- An Audio Magnetic probe.
- A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-optical converter (EOC) performs the conversion between optical and electrical of the signals for the digital communication to the DAE and for the analog signal from the optical surface detection. The EOC is connected to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- A probe alignment unit which improves the (absolute) accuracy of the probe positioning.
- A computer operating Windows 7.
- DASY5 software.
- Remote control with teach pendant and additional circuitry for robot safety such as warning lamps, etc.
- The Test Arch SAM phantom
- The device holder for handheld mobile phones.
- Validation dipole kits allowing to validate the proper functioning of the system.

3.2 E-Field Probe

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material	 <u>EF3DV3 E-Field Probe</u>
Calibration	In air from 100 MHz to 6.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$)	
Frequency	(extended to 20 MHz for MRI), Linearity: ± 0.2 dB (100 MHz to 6 GHz)	
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)	
Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB	
Dimensions	Tip diameter: 8 mm Distance from probe tip to dipole centers: 2.5 mm	

3.3 Test Arch

Description	Enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot.	 Test Arch
Dimensions	length: 370 mm width: 370 mm height: 370 mm	

3.4 Phone Holder

Description	Supports accurate and reliable positioning of any phone Effect on near field $\leq \pm 0.5$ dB	 Phone Holder
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4 Measurement uncertainty evaluation

Uncertainty Component	Uncertainty Value (%)	Probability Distribution	Divisor	ci (E)	Standard Uncertainty (E) (%)
Measurement system					
Probe calibration	±5.1	N	1	1	±5.1
Axial isotropy	±4.7	R	$\sqrt{3}$	1	±2.7
Sensor position	±16.5	R	$\sqrt{3}$	1	±9.5
Boundary effect	±2.4	R	$\sqrt{3}$	1	±1.4
Phantom Boundary Effect	±7.2	R	$\sqrt{3}$	1	±4.1
Linearity	±4.7	R	$\sqrt{3}$	1	±2.7
Scaling with PMR calibration	±10.0	R	$\sqrt{3}$	1	±5.8
System Detection limit	±1.0	R	$\sqrt{3}$	1	±0.6
Readout Electronics	±0.3	N	1	1	±0.3
Response time	±0.8	R	$\sqrt{3}$	1	±0.5
Integration time	±2.6	R	$\sqrt{3}$	1	±1.5
RF ambient conditions	±3.0	R	$\sqrt{3}$	1	±1.7
RF reflection	±12.0	R	$\sqrt{3}$	1	±6.9
Probe positioner	±1.2	R	$\sqrt{3}$	1	±0.7
Probe positioning	±4.7	R	$\sqrt{3}$	1	±2.7
Extrapolation and interpolation	±1.0	R	$\sqrt{3}$	1	±0.6
Related to test samples					
Device Positioning Vertical	±4.7	R	$\sqrt{3}$	1	±2.7
Device Positioning Lateral	±1.0	R	$\sqrt{3}$	1	±0.6
Device Holder and Phantom	±2.4	R	$\sqrt{3}$	1	±1.4
Power drift	±5.0	R	$\sqrt{3}$	1	±2.9
Phantom and Setup Related					
Phantom Thickness	±2.4	R	$\sqrt{3}$	1	±1.4
Combined Std. Uncertainty	$u'_c = \sqrt{\sum_{i=1}^{21} c_i^2 u_i^2}$				±16.3
Expanded Std. Uncertainty on Power (K=2)					±32.6
Expanded Std. Uncertainty on Field (K=2)					±16.3

Table 3: Measurement uncertainties for RF

5 RF Emission Measurements Reference and Plane

Fig.3 illustrate the references and reference plane that shall be used in a typical EUT emissions measurement. The principle of this section is applied to EUT with similar geometry. Please refer to Appendix C for the setup photographs.

- ◆ The area is 5 cm by 5 cm.
- ◆ The area is centered on the audio frequency output transducer of the EUT.
- ◆ The area is in a reference plane, which is defined as the planar area that contains the highest point in the area of the phone that normally rests against the user's ear. It is parallel to the centerline of the receiver area of the phone and is defined by the points of the receiver-end of the EUT handset, which, in normal handset use, rest against the ear.
- ◆ The measurement plane is parallel to, and 10 mm in front of, the reference plane.



Fig.3 WD reference and plane for RF emission measurements

6 System Verification Procedure

6.1 System Check

Place a dipole antenna meeting the requirements given in ANSI C63.19-2011 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field probe so that the following occurs:

- The probes and their cables are parallel to the coaxial feed of the dipole antenna
- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions

- The center point of the probe element(s) are 15 mm from the closest surface of the dipole elements.

Scan the length of the dipole with the E-field probe and record the two maximum values found near the dipole ends. Average the two readings and compare the reading to the expected value in the calibration certificate or the expected value in this standard.

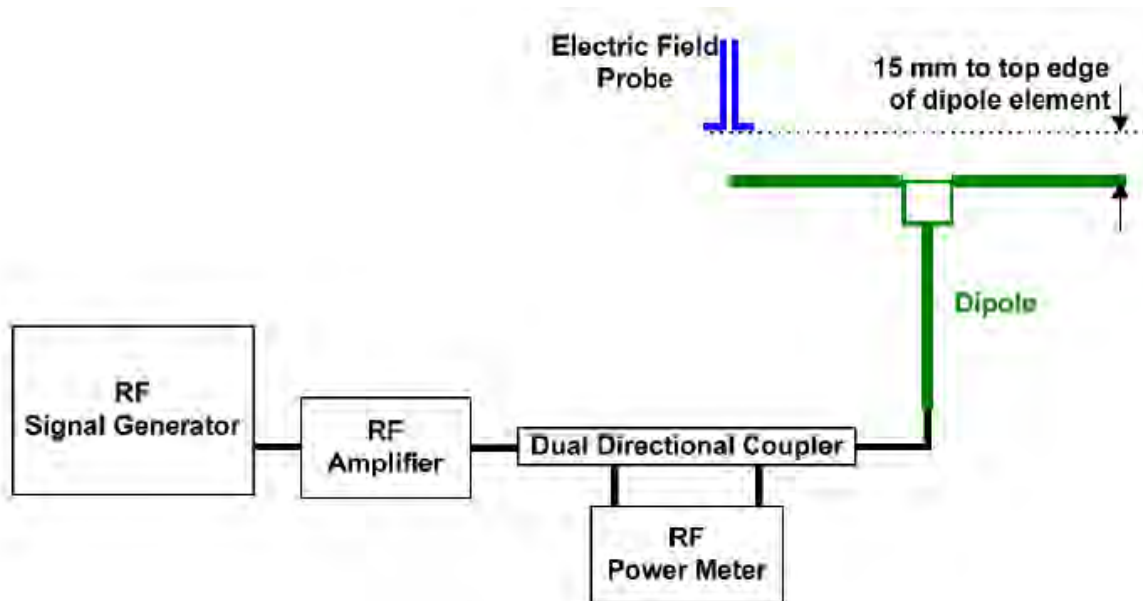


Fig.4 System verification

6.2 System Check Result

Frequency (MHz)	Input Power (mW)	E-Field Value 1 (V/m)	E-Field Value 2 (V/m)	Averaged Measured* Value(V/m)	Target** Value (V/m)	Deviation*** (%)	Limit**** (%)	Test Date
835	100	106.40	116.80	111.60	106.8	4.49	±18	2020/08/26
1880	100	88.67	92.46	90.57	86.9	4.22	±18	2020/08/26
2600	100	83.77	91.22	87.50	83.5	4.78	±18	2020/08/26
2600	100	89.05	97.13	93.09	83.5	11.49	±18	2020/09/01

Note:

* Please refer to the appendix A for detailed measurement data and plot.

** Target value is provided by SPEAD in the calibration certificate of specific dipoles.

*** Deviation (%) = 100 * (Measured value minus Target value) divided by Target value.

**** ANSI C63.19 requires values within ± 18% are acceptable.



7 Modulation Interference Factor

The HAC Standard ANSI C63.19-2011 defines a new scaling using the Modulation Interference Factor (MIF). For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be developed that relates its interference potential to its steady-state rms signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. It is important to emphasize that the MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic. Any change in modulation characteristic requires determination and application of a new MIF.

The Modulation Interference factor (MIF, in dB) is added to the measured average E-field (in dBV/m) and converts it to the RF Audio Interference level (in dBV/m). This level considers the audible amplitude modulation components in the RF E-field. CW fields without amplitude modulation are assumed to not interfere with the hearing aid electronics.

Modulations without time slots and low fluctuations at low frequencies have low MIF values, TDMA modulations with narrow transmission and repetition rates of few 100 Hz have high MIF values and give similar classifications as ANSI C63.19-2011.

ER3D, EF3D and EU2D E-field probes have a bandwidth <10 kHz and can therefore not evaluate the RF envelope in the full audio band. DASY52 is therefore using the indirect measurement method according to ANSI C63.19-2011 which is the primary method. These near field probes read the averaged E-field measurement. Especially for the new high peak-to-average (PAR) signal types, the probes shall be linearized by PMR calibration in order to not overestimate the field reading. Probe Modulation Response (PMR) calibration linearizes the probe response over its dynamic range for specific modulations which are characterized by their UID and result in an uncertainty specified in the probe calibration certificate. The MIF is characteristic for a given waveform envelope and can be used as a constant conversion factor if the probe has been PMR calibrated.

The evaluation method for the MIF is defined in ANSI C63.19-2011 section D.7. An RMS demodulated RF signal is fed to a spectral filter (similar to an A weighting filter) and forwarded to a temporal filter acting as a quasi-peak detector. The averaged output of these filtering is scaled to a 1 kHz 80% AM signal as reference. MIF measurement requires additional instrumentation and is not well suited for evaluation by the end user with reasonable uncertainty.

It may alternatively be determined through analysis and simulation, because it is constant and characteristic for a communication signal. DASY52 uses well-defined signals for PMR calibration. The MIF of these signals has been determined by simulation and it is automatically applied.

The MIF measurement uncertainty is estimated as follows, declared by HAC equipment provider SPEAG, for modulation frequencies from slotted waveforms with fundamental frequency and at least 2 harmonics within 10 kHz:

1. 0.2 dB for MIF: -7 to +5 dB
2. 0.5 dB for MIF: -13 to +11 dB
3. 1 dB for MIF: > -20 dB

MIF values applied in this test report were provided by the HAC equipment provider of SPEAG, and the worst values for all air interface are listed below to determine the Low-power Exemption.



SPEAG UID	UID version	Communication system	MIF(dB)
10021	DAC	GSM-FDD (TDMA,GMSK)	3.63
10025	DAC	EDGE-FDD (TDMA, 8PSK, TN 0)	3.75
10460	AAA	UMTS-FDD (WCDMA, AMR)	-25.43
10225	AAA	UMTS-FDD (HSPA+)	-20.39
10295	AAB	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	3.26
10403	AAB	CDMA2000 (1xEV-DO, Rev. 0)	-17.67
10169	CAE	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, QPSK)	-15.63
10170	CAE	LTE-FDD (SC-FDMA,1RB, 20 MHz,16-QAM)	-9.76
10172	CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK)	-1.62
10173	CAG	LTE-TDD (SC-FDMA,1RB, 20 MHz,16-QAM)	-1.44
10061	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	-2.02
10077	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 54 Mbps)	0.12
10427	AAB	IEEE 802.11n (HT Green eld, 150 Mbps, 64-QAM)	-13.44



8 HAC Measurement Procedure

The evaluation was performed with the following procedure:

- a) Confirm the proper operation of the field probe, probe measurement system, and other instrumentation and the positioning system.
 - b) Position the WD in its intended test position.
 - c) Set the WD to transmit a fixed and repeatable combination of signal power and modulation characteristic that is representative of the worst case (highest interference potential) encountered in normal use. Transiently occurring start-up, changeover, or termination conditions, or other operations likely to occur less than 1% of the time during normal operation, may be excluded from consideration.
 - d) The center subgrid shall be centered on the T-Coil mode perpendicular measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane, refer to illustrated in Figure 3. If the field alignment method is used, align the probe for maximum field reception.
 - e) Record the reading at the output of the measurement system.
 - f) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
 - g) Identify the five contiguous subgrids around the center subgrid whose maximum reading is the lowest of all available choices. This eliminates the three subgrids with the maximum readings. Thus, the six areas to be used to determine the WD's highest emissions are identified.
 - h) Identify the maximum reading within the nonexcluded subgrids identified in step g).
 - i) Convert the maximum reading identified in step h) to RF audio interference level, in, V/m, by taking the square root of the reading and then dividing it by the measurement system transfer function, established in 5.5.1.1. Convert the result to dB(V/m) by taking the base-10 logarithm and multiplying it by 20.
- Indirect measurement method**
- Replacing step i) of 5.5.1.2, the RF audio interference level in dB(V/m) is obtained by adding the MIF (in dB) to the maximum steady-state rms field-strength reading, in dB(V/m), from step h). Use this result to determine the category rating.
- j) Compare this RF audio interference level with the categories in Clause 8 and record the resulting WD category rating.
 - k) For the T-Coil mode M-rating assessment, determine whether the chosen perpendicular measurement point is contained in an included subgrid of the first scan. If so, then a second scan is not necessary. The first scan and resultant category rating may be used for the T-Coil mode M rating.
- Otherwise, repeat step a) through step i), with the grid shifted so that it is centered on the perpendicular measurement point. Record the WD category rating.



9 HAC RF Measurement Results

9.1 Conducted RF Output Power

GSM 850				
Burst Output Power(dBm)				Tune up
Channel	128	190	251	
GSM (GMSK, 1 Tx slot)	31.35	31.57	31.77	32.50
GSM 1900				
Burst Output Power(dBm)				Tune up
Channel	512	661	810	
GSM (GMSK, 1 Tx slot)	28.88	29.06	29.18	30.00

CDMA BC0				
Average Conducted Power(dBm)				
Channel	1013	384	777	Tune up
1xRTT RC1 SO3, 1/8th Rate	23.62	23.78	23.67	24.80
CDMA BC1				
Average Conducted Power(dBm)				
Channel	25	600	1175	Tune up
1xRTT RC1 SO3, 1/8th Rate	24.08	24.09	24.14	24.80
CDMA BC10				
Average Conducted Power(dBm)				
Channel	476	580	684	Tune up
1xRTT RC1 SO3, 1/8th Rate	23.23	23.18	23.20	24.80

LTE Band 41 PC3				Conducted Power(dBm)					
Bandwidth	Modulation	RB size	RB offset	Channel	Channel	Channel	Channel	Channel	Tune up
				39750	40185	40620	41055	41490	
20MHz	QPSK	1	0	22.76	23.02	23.56	23.25	23.07	24.00
		1	50	23.27	23.38	23.52	23.54	23.39	24.00
		1	99	22.96	23.00	23.25	23.31	23.09	24.00
		50	0	22.39	22.48	22.77	22.71	22.62	23.00
		50	25	22.32	22.46	22.60	22.62	22.56	23.00
		50	50	22.42	22.39	22.58	22.55	22.24	23.00
		100	0	22.26	22.44	22.54	22.62	22.47	23.00
	16QAM	1	0	21.68	21.85	22.16	22.10	22.11	23.00
		1	50	21.83	22.46	22.08	22.29	21.92	23.00
		1	99	21.79	21.88	21.94	21.85	21.59	23.00
		50	0	21.15	21.41	21.45	21.57	21.46	22.00
		50	25	21.27	21.13	21.25	21.30	21.42	22.00
		50	50	21.17	21.35	21.43	21.52	21.38	22.00
		100	0	21.10	21.36	21.48	21.58	21.41	22.00



LTE Band 41 PC2				Conducted Power(dBm)					
Bandwidth	Modulation	RB size	RB offset	Channel	Channel	Channel	Channel	Channel	Tune up
				39750	40185	40620	41055	41490	
20MHz	QPSK	1	0	25.76	25.97	26.07	26.06	25.98	26.50
		1	50	25.40	25.61	25.73	25.60	25.61	26.50
		1	99	25.49	25.82	25.61	25.65	25.14	26.50
		50	0	24.70	24.96	25.15	24.98	24.95	25.50
		50	25	24.77	24.93	25.00	24.99	24.87	25.50
		50	50	24.73	24.90	24.93	24.85	24.65	25.50
		100	0	24.90	24.86	24.93	24.92	24.85	25.50
	16QAM	1	0	24.49	24.63	24.53	24.25	24.77	25.50
		1	50	25.00	25.00	25.29	24.89	25.12	25.50
		1	99	24.54	24.72	24.41	24.36	24.52	25.50
		50	0	23.68	23.96	24.20	23.82	23.87	24.50
		50	25	23.77	23.87	24.22	23.87	23.76	24.50
		50	50	23.74	23.83	23.95	23.81	23.58	24.50
		100	0	23.78	23.83	23.98	23.91	23.74	24.50

Note:

1. LTE Band 41 PC2 is LTE Band 41 Power Class 2, LTE Band 41 PC3 is LTE Band 41 Power Class 3.



9.1 Max Tune-up

Frequency Band			Average Power (dBm)
GSM	GSM850		32.50
	EDGE850		25.50
	GSM1900		30.00
	EDGE1900		25.50
WCDMA	Band V		25.00
	Band IV		24.00
	Band II		25.00
	HSPA		23.80
CDMA	BC0		24.80
	BC1		24.80
	BC10		24.80
	EVDO		24.80
FDD LTE	Band 2		24.00
	Band 4		25.00
	Band 5		25.00
	Band 12		25.00
	Band 13		25.00
	Band 25		24.00
	Band 26		25.00
	Band 66		25.00
TDD LTE	Band 41 PC2	QPSK	26.50
		16QAM	25.50
TDD LTE	Band 41 PC3	QPSK	24.00
		16QAM	23.00

Frequency Band			Average Power (dBm)
2.4GHz WLAN	802.11b		18.00
	802.11g		12.00
	802.11n-HT20		11.00
	802.11n-HT40		11.00



9.2 Low-power Exemption

According to ANSI C63.19-2011, a RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤ 17 dBm for any of its operation modes.

Air Interface (Ant1)		Max Average Antenna Input Power (dBm)	Worst Case MIF (dB)	Power + MIF (dB)	C63.19 test required
GSM850		32.50	3.63	36.13	Yes
EDGE850		25.50	3.75	29.25	No
GSM1900		30.00	3.63	33.63	Yes
EDGE1900		25.50	3.75	29.25	No
WCDMA		25.00	-25.43	-0.43	No
WCDMA - HSPA		23.80	-20.39	3.41	No
CDMA Full Frame Rate		24.80	-19.43	5.37	No
CDMA 1/8th Frame Rate		24.80	3.26	28.06	Yes
CDMA - EVDO		24.80	-17.67	7.13	No
LTE - FDD		25.00	-9.76	15.24	No
LTE Band 41 PC2	QPSK	26.50	-1.62	24.88	Yes
	16QAM	25.50	-1.44	24.06	No
LTE Band 41 PC3	QPSK	24.00	-1.62	22.38	Yes
	16QAM	23.00	-1.44	21.56	No

Air Interface		Max Average Antenna Input Power (dBm)	Worst Case MIF (dB)	Power + MIF (dB)	C63.19 test required
802.11b		18.00	-2.02	15.98	No
802.11g		12.00	0.12	12.12	No
802.11n-HT20		11.00	-13.44	-2.44	No
802.11n-HT40		11.00	-13.44	-2.44	No

General Note:

- EDGE data modes and 16QAM/64QAM is not necessary due the GSM Voice mode and QPSK is the worst case.
- According to ANSI C63.19 2011-version, for the air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤ 17 dBm for any of its operating modes.
- HAC RF rating is M4 for the air interface which meets the low power exemption.



9.3 HAC RF Emission Test Results

Band	Test Mode	Channel	Frequency (MHz)	MIF (dB)	Audio Interference Level (dBV/m)	Margin to FCC M3 limit (dB)	Category
GSM850	GSM Voice	128	824.2	3.63	34.79	10.21	M4
GSM850	GSM Voice	190	836.6	3.63	35.99	9.01	M4
GSM850	GSM Voice	251	848.8	3.63	36.97	8.03	M4
GSM1900	GSM Voice	512	1850.2	3.63	26.14	8.86	M4
GSM1900	GSM Voice	661	1880	3.63	27.67	7.33	M4
GSM1900	GSM Voice	810	1909.8	3.63	28.02	6.98	M4
CDMA BC0	RC1 SO3 1/8th Frame Rate	1013	824.7	3.26	29.30	15.70	M4
CDMA BC0	RC1 SO3 1/8th Frame Rate	384	836.52	3.26	31.92	13.08	M4
CDMA BC0	RC1 SO3 1/8th Frame Rate	777	848.31	3.26	30.23	14.77	M4
CDMA BC1	RC1 SO3 1/8th Frame Rate	25	1851.25	3.26	23.56	11.44	M4
CDMA BC1	RC1 SO3 1/8th Frame Rate	600	1880	3.26	23.82	11.18	M4
CDMA BC1	RC1 SO3 1/8th Frame Rate	1175	1908.75	3.26	23.55	11.45	M4
CDMA BC10	RC1 SO3 1/8th Frame Rate	476	817.9	3.26	28.91	16.09	M4
CDMA BC10	RC1 SO3 1/8th Frame Rate	580	820.5	3.26	28.98	16.02	M4
CDMA BC10	RC1 SO3 1/8th Frame Rate	684	823.1	3.26	28.97	16.03	M4
LTE Band 41 PC3	20M QPSK 1RB_50	39750	2506	-1.62	17.81	17.19	M4
LTE Band 41 PC3	20M QPSK 1RB_50	40185	2549.5	-1.62	19.89	15.11	M4
LTE Band 41 PC3	20M QPSK 1RB_0	40620	2593	-1.62	19.56	15.44	M4
LTE Band 41 PC3	20M QPSK 1RB_50	41055	2636.5	-1.62	19.95	15.05	M4
LTE Band 41 PC3	20M QPSK 1RB_50	41490	2680	-1.62	20.66	14.34	M4
LTE Band 41 PC2	20M QPSK 1RB_0	39750	2506	-1.62	18.53	16.47	M4
LTE Band 41 PC2	20M QPSK 1RB_0	40185	2549.5	-1.62	20.69	14.31	M4
LTE Band 41 PC2	20M QPSK 1RB_0	40620	2593	-1.62	20.52	14.48	M4
LTE Band 41 PC2	20M QPSK 1RB_0	41055	2636.5	-1.62	22.51	12.49	M4
LTE Band 41 PC2	20M QPSK 1RB_0	41490	2680	-1.62	21.83	13.17	M4

Remark:

1. The detail RF Emission results please refer to appendix B.
2. LTE Band 41 PC2 is LTE Band 41 Power Class 2, LTE Band 41 PC3 is LTE Band 41 Power Class 3.



10 Equipment list

Equipment	Manufacturer	Model	Serial Number	Calibration Date	Due date of calibration
☒ Software	SPEAG	DASY52	NA	NCR	NCR
☒ DAE	SPEAG	DAE4	896	2020-06-11	2021-06-10
☒ E-Field Probe	SPEAG	EF3DV3	4051	2020-05-29	2021-05-28
☒ Validation Kits	SPEAG	CD835V3	1052	2020-05-25	2021-05-24
☒ Validation Kits	SPEAG	CD1880V3	1044	2020-05-25	2021-05-24
☒ Validation Kits	SPEAG	CD2600V3	1021	2020-05-25	2021-05-24
☒ Test Arch SD HAC	SPEAG	NA	NA	NCR	NCR
☒ Universal Radio Communication Tester	R&S	CMU200	123090	2020-06-11	2021-06-10
☒ Universal Radio Communication Tester	R&S	CMW500	111637	2020-04-16	2021-04-15
☒ Signal Generator	Agilent	N5171B	MY53050736	2020-04-15	2021-04-14
☒ Preamplifier	Mini-Circuits	ZHL-42W	15542	NCR	NCR
☒ Power Meter	Agilent	E4416A	GB41292095	2020-04-15	2021-04-14
☒ Power Sensor	Agilent	8481H	MY41091234	2020-04-15	2021-04-14
☒ Power Sensor	R&S	NRP-Z92	100025	2020-04-16	2021-04-15
☒ Attenuator	SHX	TS2-3dB	30704	NCR	NCR
☒ Coaxial low pass filter	Mini-Circuits	VLF-2500(+)	NA	NCR	NCR
☒ Coaxial low pass filter	Microlab Fxr	LA-F13	NA	NCR	NCR
☒ DC POWER SUPPLY	SAKO	SK1730SL5A	NA	NCR	NCR
☒ Humidity and Temperature Indicator	KIMTOKA	KIMTOKA	NA	2020-04-21	2021-04-20

Note:

1. All the equipments are within the valid period when the tests are performed.
2. NCR: "No-Calibration Required".



11 Calibration certificate

Please see the Appendix B

12 Photographs

Please see the Appendix C

Appendix A: Detailed System Check Results

Appendix B: Detailed Test Results

Appendix C: Calibration certificate

Appendix D: Photographs

---END---



Appendix A

Detailed System Check Results

1. System Check Results
System Performance Check 835 MHz
System Performance Check 1880 MHz
System Performance Check 2600 MHz

Test Laboratory: SGS-SAR Lab

HAC-E-Dipole CD835V3

DUT: CD835V3; Type: CD835V3; Serial: 1052

Communication System: UID 0, CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement/E Scan - measurement distance from the probe sensor center to CD835 = 15mm/Hearing Aid Compatibility Test at 15mm distance

(41x361x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 180.8 V/m; Power Drift = -0.05 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 106.4 V/m

Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

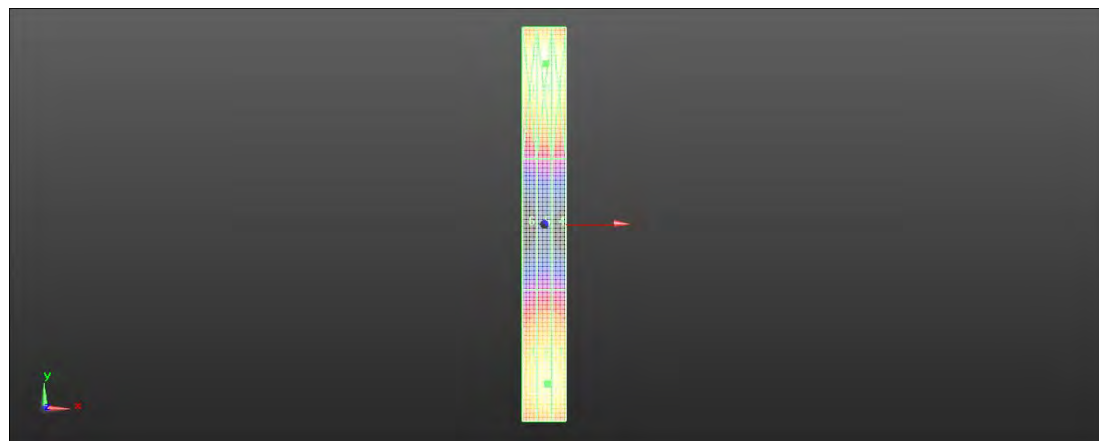
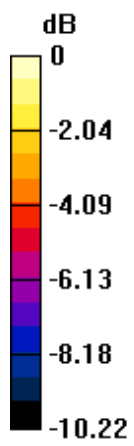
Grid 1 M4 105.9 V/m	Grid 2 M4 106.4 V/m	Grid 3 M4 103.0 V/m
Grid 4 M4 63.15 V/m	Grid 5 M4 63.35 V/m	Grid 6 M4 61.11 V/m
Grid 7 M4 114.9 V/m	Grid 8 M4 116.8 V/m	Grid 9 M4 113.4 V/m

Cursor:

Total = 116.8 V/m

E Category: M4

Location: 0.5, 73.5, 8.7 mm



0 dB = 116.8 V/m = 41.35 dBV/m

Test Laboratory: SGS-SAR Lab

HAC-E-Dipole CD1880V3

DUT: CD1880V3; Type: CD1880V3; Serial: 1044

Communication System: UID 0, CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement/E Scan - measurement distance from the probe sensor center to CD1880 = 15mm/Hearing Aid Compatibility Test at 15mm distance

(41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 156.1 V/m; Power Drift = -0.06 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 88.67 V/m

Near-field category: M3 (AWF 0 dB)

PMF scaled E-field

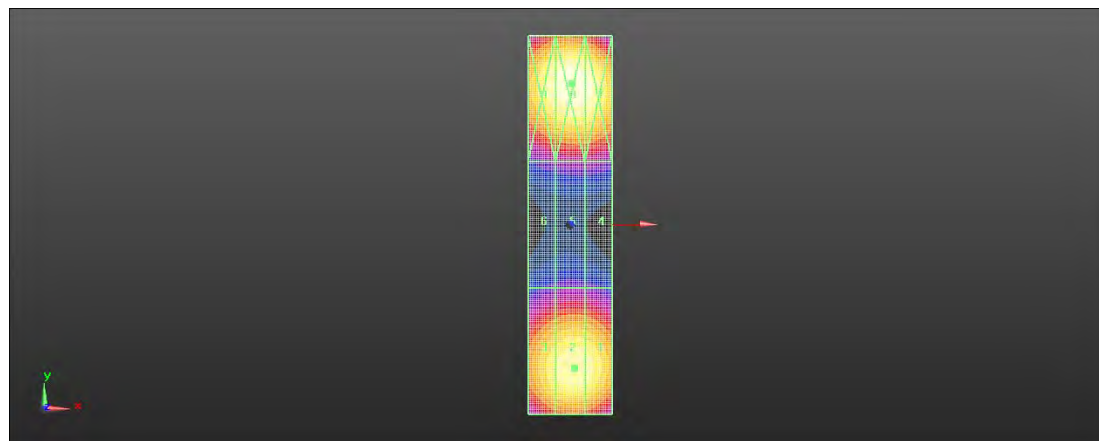
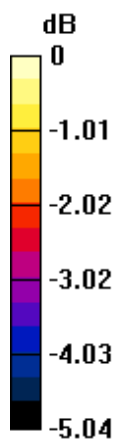
Grid 1 M3 87.85 V/m	Grid 2 M3 88.67 V/m	Grid 3 M3 85.79 V/m
Grid 4 M3 65.71 V/m	Grid 5 M3 65.72 V/m	Grid 6 M3 64.34 V/m
Grid 7 M3 91.15V/m	Grid 8 M3 92.46 V/m	Grid 9 M3 89.67 V/m

Cursor:

Total = 92.46 V/m

E Category: M3

Location: 0.5, 33.5, 8.7 mm



0 dB = 92.46 V/m = 39.32 dBV/m

Test Laboratory: SGS-SAR Lab

HAC-E-Dipole CD2600V3

DUT: CD2600V3; Type: CD2600V3; Serial: 1021

Communication System: UID 0, CW (0); Frequency: 2600 MHz; Duty Cycle: 1:1

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement/E Scan - measurement distance from the probe sensor center to CD2600 = 15mm/Hearing Aid Compatibility Test at 15mm distance

(41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 68.86 V/m; Power Drift = -0.04 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 83.77 V/m

Near-field category: M3 (AWF 0 dB)

PMF scaled E-field

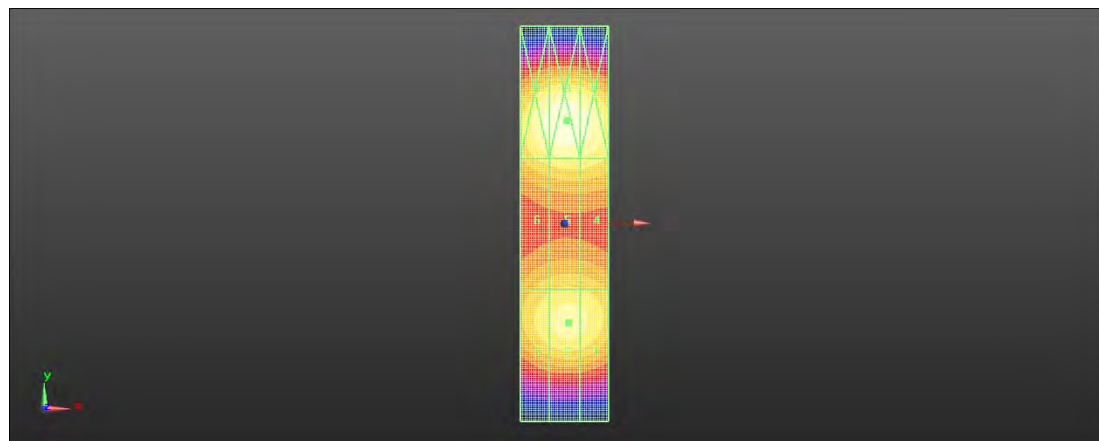
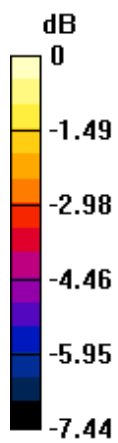
Grid 1 M3 82.92 V/m	Grid 2 M3 83.77 V/m	Grid 3 M3 81.21 V/m
Grid 4 M3 81.19 V/m	Grid 5 M3 81.55 V/m	Grid 6 M3 79.71 V/m
Grid 7 M3 89.69 V/m	Grid 8 M3 91.22 V/m	Grid 9 M3 88.43 V/m

Cursor:

Total = 91.22 V/m

E Category: M3

Location: 0.5, 23.5, 8.7 mm



0 dB = 91.22 V/m = 39.20 dBV/m

Test Laboratory: SGS-SAR Lab

HAC-E-Dipole CD2600V3

DUT: CD2600V3; Type: CD2600V3; Serial: 1021

Communication System: UID 0, CW (0); Frequency: 2600 MHz; Duty Cycle: 1:1

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole E-Field measurement/E Scan - measurement distance from the probe sensor center to CD2600 = 15mm/Hearing Aid Compatibility Test at 15mm distance

(41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 72.79 V/m; Power Drift = -0.03 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 89.08 V/m

Near-field category: M3 (AWF 0 dB)

PMF scaled E-field

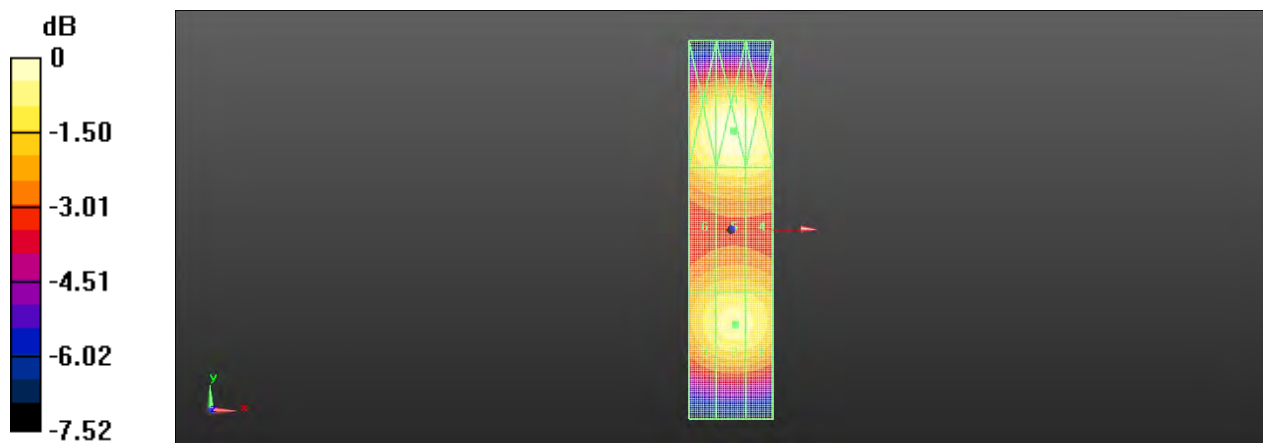
Grid 1 M3 88.17 V/m	Grid 2 M3 89.08 V/m	Grid 3 M3 86.37 V/m
Grid 4 M3 86.13 V/m	Grid 5 M3 86.54 V/m	Grid 6 M3 84.57 V/m
Grid 7 M3 95.45 V/m	Grid 8 M3 97.13 V/m	Grid 9 M3 94.10 V/m

Cursor:

Total = 97.13 V/m

E Category: M3

Location: 0.5, 23.5, 8.7 mm





Appendix B

Detailed Test Results

1. GSM
GSM850 for E-Field Emission
GSM1900 for E-Field Emission
2. CDMA
CDMA BC0 for E-Field Emission
CDMA BC1 for E-Field Emission
CDMA BC10 for E-Field Emission
3. LTE
LTE Band 41 for E-Field Emission

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-GSM850 GSM Voice 128CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000322

Communication System: UID 10021 - DAC, GSM-FDD (TDMA, GMSK); Frequency: 824.2 MHz; Duty Cycle: 1:8.6896

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 56.37 V/m; Power Drift = -0.07 dB

Applied MIF = 3.63 dB

RF audio interference level = 34.79 dBV/m

Emission category: M4

MIF scaled E-field

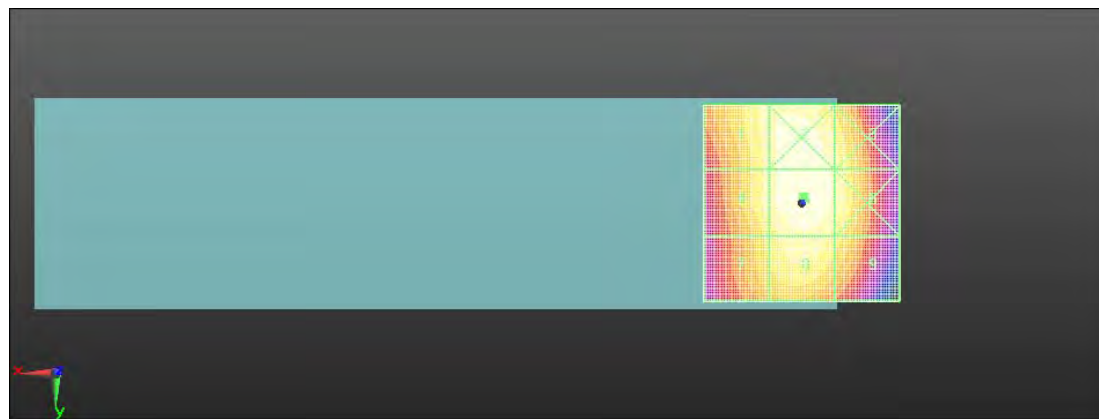
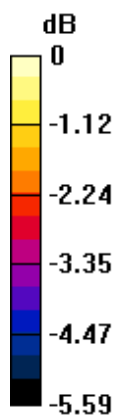
Grid 1 M4 34.27 dBV/m	Grid 2 M4 34.77 dBV/m	Grid 3 M4 34.25 dBV/m
Grid 4 M4 34.26 dBV/m	Grid 5 M4 34.79 dBV/m	Grid 6 M4 34.35 dBV/m
Grid 7 M4 33.82 dBV/m	Grid 8 M4 34.37 dBV/m	Grid 9 M4 33.93 dBV/m

Cursor:

Total = 34.79 dBV/m

E Category: M4

Location: -0.5, -1.5, 7.7 mm



0 dB = 54.92 V/m = 34.79 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-GSM850 GSM Voice 190CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000322

Communication System: UID 10021 - DAC, GSM-FDD (TDMA, GMSK); Frequency: 836.6 MHz; Duty Cycle: 1:8.6896

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 55.43 V/m; Power Drift = -0.01 dB

Applied MIF = 3.63 dB

RF audio interference level = 35.99 dBV/m

Emission category: M4

MIF scaled E-field

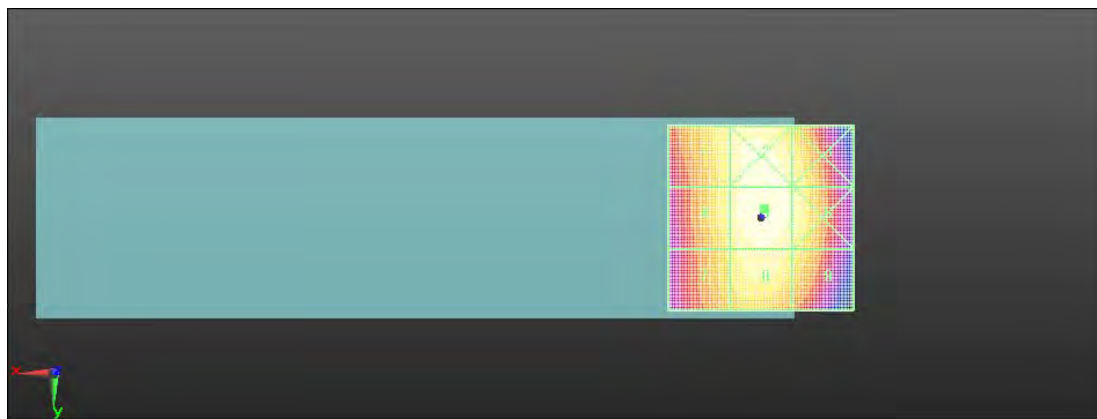
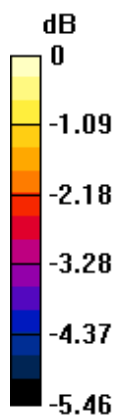
Grid 1 M4 35.37 dBV/m	Grid 2 M4 35.93 dBV/m	Grid 3 M4 35.47 dBV/m
Grid 4 M4 35.39 dBV/m	Grid 5 M4 35.99 dBV/m	Grid 6 M4 35.58 dBV/m
Grid 7 M4 35.04 dBV/m	Grid 8 M4 35.61 dBV/m	Grid 9 M4 35.19 dBV/m

Cursor:

Total = 35.99 dBV/m

E Category: M4

Location: -1, -2.5, 7.7 mm



0 dB = 63.06 V/m = 36.00 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-GSM850 GSM Voice 251CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000322

Communication System: UID 10021 - DAC, GSM-FDD (TDMA, GMSK); Frequency: 848.8 MHz; Duty Cycle: 1:8.6896

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 62.18 V/m; Power Drift = -0.00 dB

Applied MIF = 3.63 dB

RF audio interference level = 36.97 dBV/m

Emission category: M4

MIF scaled E-field

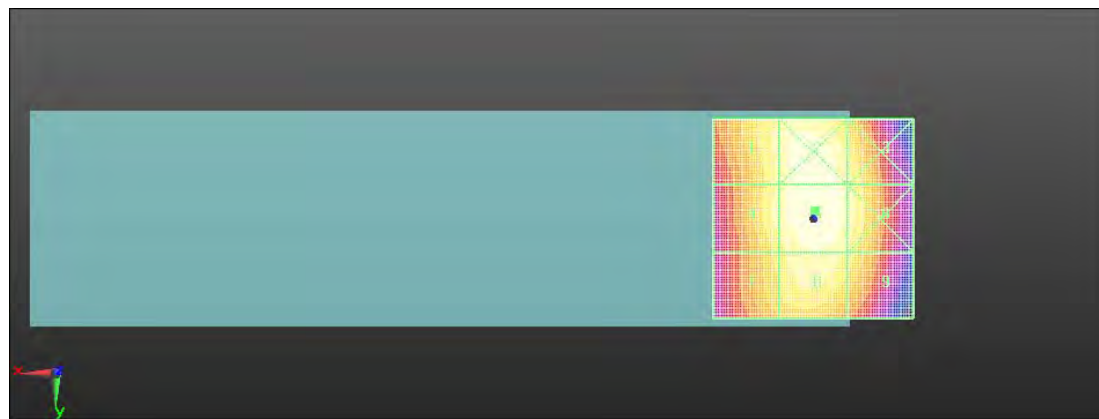
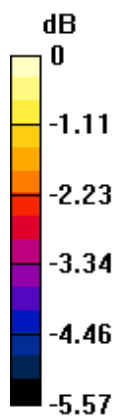
Grid 1 M4 36.39 dBV/m	Grid 2 M4 36.87 dBV/m	Grid 3 M4 36.42 dBV/m
Grid 4 M4 36.42 dBV/m	Grid 5 M4 36.97 dBV/m	Grid 6 M4 36.51 dBV/m
Grid 7 M4 36.06 dBV/m	Grid 8 M4 36.59 dBV/m	Grid 9 M4 36.15 dBV/m

Cursor:

Total = 36.97 dBV/m

E Category: M4

Location: -0.5, -2, 7.7 mm



0 dB = 70.53 V/m = 36.97 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-GSM1900 GSM Voice 512CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000322

Communication System: UID 10021 - DAC, GSM-FDD (TDMA, GMSK); Frequency: 1850.2 MHz; Duty Cycle: 1:8.6896

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 13.52 V/m; Power Drift = 0.11 dB

Applied MIF = 3.63 dB

RF audio interference level = 26.14 dBV/m

Emission category: M4

MIF scaled E-field

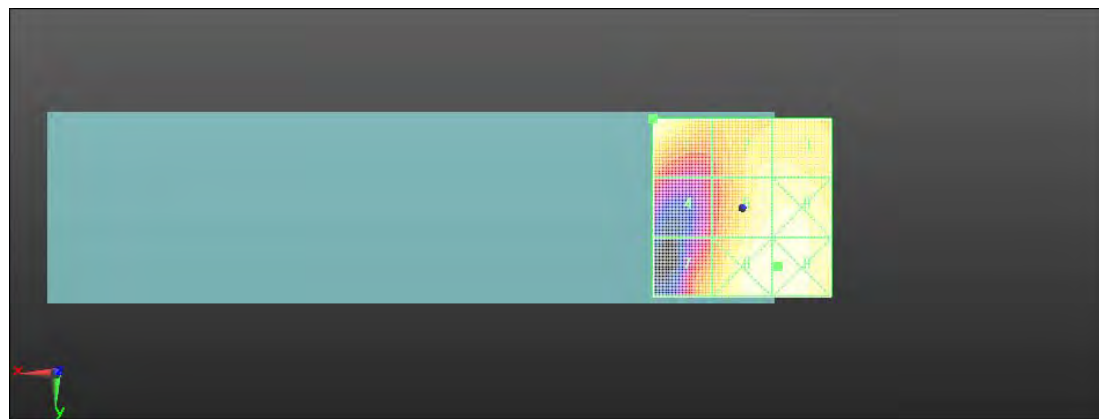
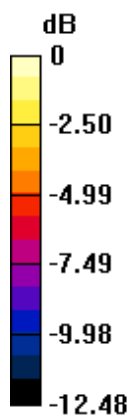
Grid 1 M4 26.14 dBV/m	Grid 2 M4 24.82 dBV/m	Grid 3 M4 24.84 dBV/m
Grid 4 M4 21.43 dBV/m	Grid 5 M4 25.83 dBV/m	Grid 6 M4 25.94 dBV/m
Grid 7 M4 23.45 dBV/m	Grid 8 M4 26.18 dBV/m	Grid 9 M4 26.19 dBV/m

Cursor:

Total = 26.19 dBV/m

E Category: M4

Location: -10, 16.5, 7.7 mm



0 dB = 20.40 V/m = 26.19 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-GSM1900 GSM Voice 661CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000322

Communication System: UID 10021 - DAC, GSM-FDD (TDMA, GMSK); Frequency: 1850.2 MHz; Duty Cycle: 1:8.6896

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 14.98 V/m; Power Drift = 0.02 dB

Applied MIF = 3.63 dB

RF audio interference level = 27.67 dBV/m

Emission category: M4

MIF scaled E-field

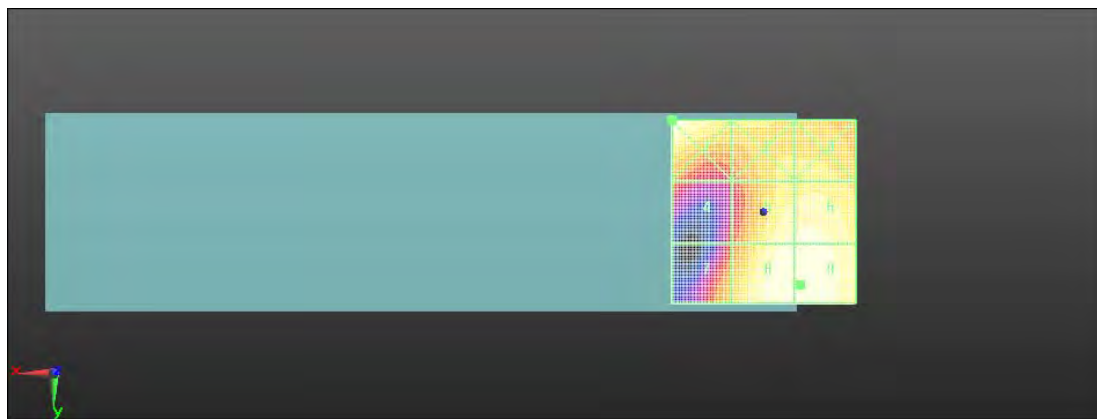
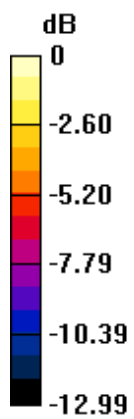
Grid 1 M4 27.68 dBV/m	Grid 2 M4 25.49 dBV/m	Grid 3 M4 25.59 dBV/m
Grid 4 M4 23.1 dBV/m	Grid 5 M4 27.16 dBV/m	Grid 6 M4 27.27 dBV/m
Grid 7 M4 24.6 dBV/m	Grid 8 M4 27.65 dBV/m	Grid 9 M4 27.67 dBV/m

Cursor:

Total = 27.68 dBV/m

E Category: M4

Location: 25, -25, 7.7 mm



0 dB = 24.20 V/m = 27.68 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-GSM1900 GSM Voice 810CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000322

Communication System: UID 10021 - DAC, GSM-FDD (TDMA, GMSK); Frequency: 1850.2 MHz; Duty Cycle: 1:8.6896

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 15.90 V/m; Power Drift = -0.02 dB

Applied MIF = 3.63 dB

RF audio interference level = 28.02 dBV/m

Emission category: M4

MIF scaled E-field

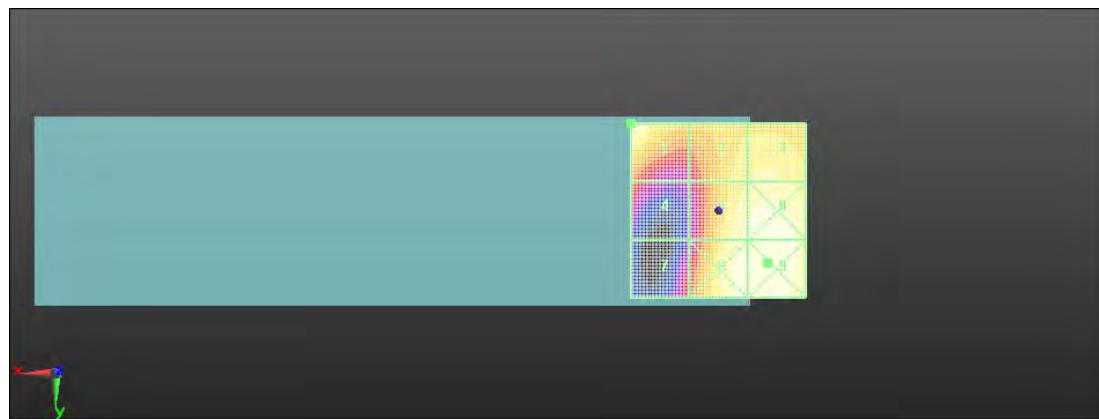
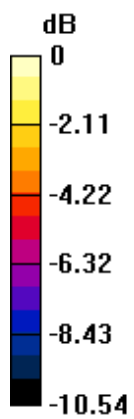
Grid 1 M4 28.02 dBV/m	Grid 2 M4 26.75 dBV/m	Grid 3 M4 27.02 dBV/m
Grid 4 M4 24.38 dBV/m	Grid 5 M4 27.71 dBV/m	Grid 6 M4 27.99 dBV/m
Grid 7 M4 23.46 dBV/m	Grid 8 M4 27.94 dBV/m	Grid 9 M4 28.13 dBV/m

Cursor:

Total = 28.13 dBV/m

E Category: M4

Location: -14, 15, 7.7 mm



0 dB = 25.50 V/m = 28.13 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC0 RC1 SO3 1013CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 824.7 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 26.82 V/m; Power Drift = -0.06 dB

Applied MIF = 3.26 dB

RF audio interference level = 29.30 dBV/m

Emission category: M4

MIF scaled E-field

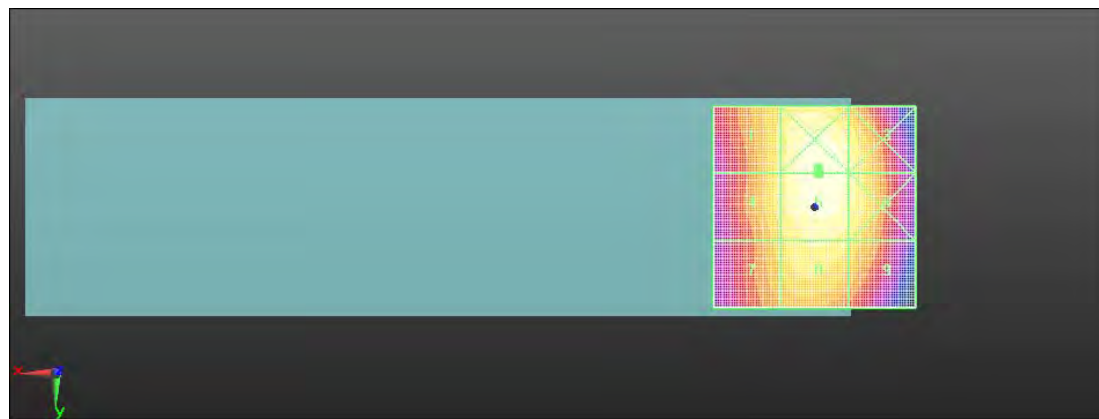
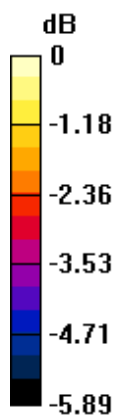
Grid 1 M4 28.38 dBV/m	Grid 2 M4 29.31 dBV/m	Grid 3 M4 28.77 dBV/m
Grid 4 M4 28.39 dBV/m	Grid 5 M4 29.3 dBV/m	Grid 6 M4 28.77 dBV/m
Grid 7 M4 28 dBV/m	Grid 8 M4 28.61 dBV/m	Grid 9 M4 28.19 dBV/m

Cursor:

Total = 29.31 dBV/m

E Category: M4

Location: -1, -9.5, 7.7 mm



0 dB = 29.22 V/m = 29.31 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC0 RC1 SO3 384CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 836.52 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 28.50 V/m; Power Drift = -0.04 dB

Applied MIF = 3.26 dB

RF audio interference level = 31.92 dBV/m

Emission category: M4

MIF scaled E-field

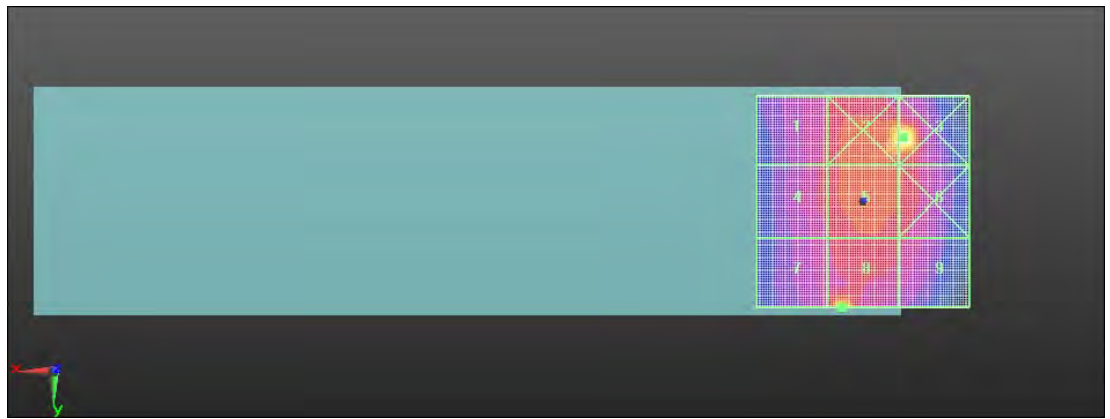
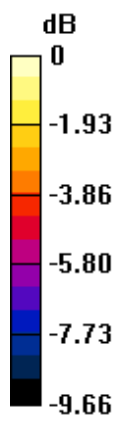
Grid 1 M4 28.82 dBV/m	Grid 2 M4 32.84 dBV/m	Grid 3 M4 33.73 dBV/m
Grid 4 M4 28.92 dBV/m	Grid 5 M4 29.78 dBV/m	Grid 6 M4 29.36 dBV/m
Grid 7 M4 28.52 dBV/m	Grid 8 M4 31.92 dBV/m	Grid 9 M4 28.81 dBV/m

Cursor:

Total = 33.73 dBV/m

E Category: M4

Location: -9.5, -15, 7.7 mm



0 dB = 48.60 V/m = 33.73 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC0 RC1 SO3 777CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 848.31 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 29.60 V/m; Power Drift = -0.02 dB

Applied MIF = 3.26 dB

RF audio interference level = 30.23 dBV/m

Emission category: M4

MIF scaled E-field

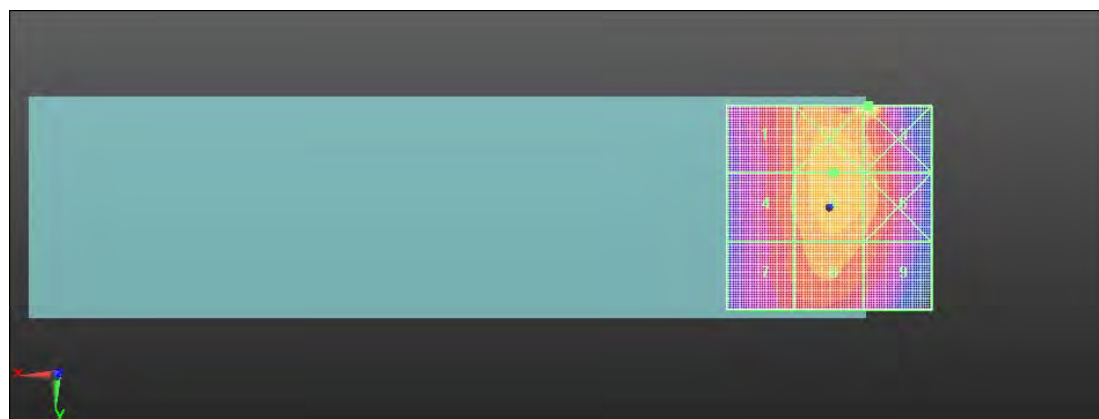
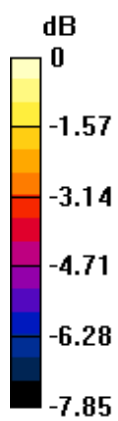
Grid 1 M4 29.22 dBV/m	Grid 2 M4 31.87 dBV/m	Grid 3 M4 32.34 dBV/m
Grid 4 M4 29.34 dBV/m	Grid 5 M4 30.23 dBV/m	Grid 6 M4 29.74 dBV/m
Grid 7 M4 28.95 dBV/m	Grid 8 M4 29.63 dBV/m	Grid 9 M4 29.18 dBV/m

Cursor:

Total = 32.34 dBV/m

E Category: M4

Location: -9.5, -25, 7.7 mm



0 dB = 41.39 V/m = 32.34 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC1 RC1 SO3 25CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 1851.25 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 11.37 V/m; Power Drift = -0.06 dB

Applied MIF = 3.26 dB

RF audio interference level = 23.56 dBV/m

Emission category: M4

MIF scaled E-field

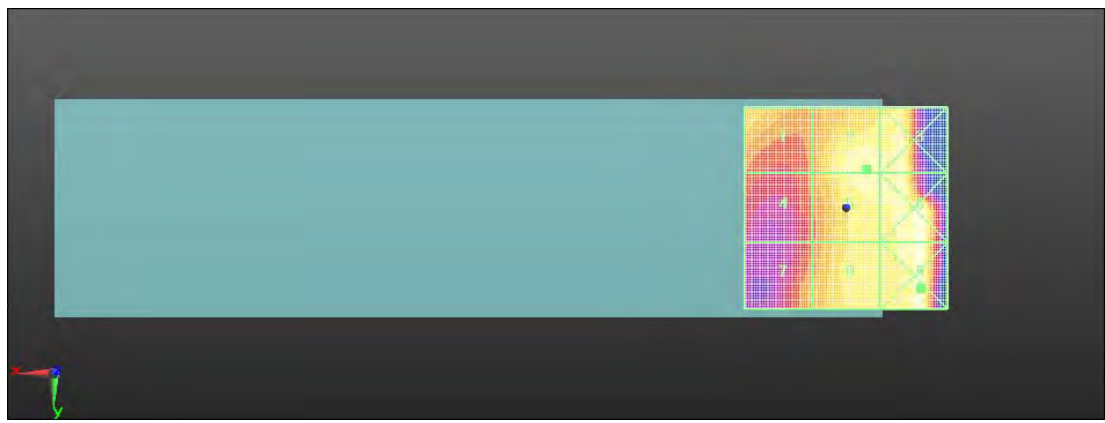
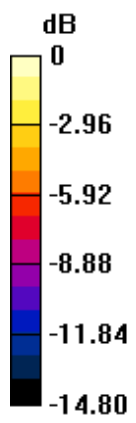
Grid 1 M4 22.26 dBV/m	Grid 2 M4 23.56 dBV/m	Grid 3 M4 24.1 dBV/m
Grid 4 M4 19.46 dBV/m	Grid 5 M4 23.52 dBV/m	Grid 6 M4 24.83 dBV/m
Grid 7 M4 20.54 dBV/m	Grid 8 M4 22.87 dBV/m	Grid 9 M4 25.03 dBV/m

Cursor:

Total = 25.03 dBV/m

E Category: M4

Location: -18.5, 20, 7.7 mm



0 dB = 17.85 V/m = 25.03 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC1 RC1 SO3 600CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 1880 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 11.75 V/m; Power Drift = 0.08 dB

Applied MIF = 3.26 dB

RF audio interference level = 23.82 dBV/m

Emission category: M4

MIF scaled E-field

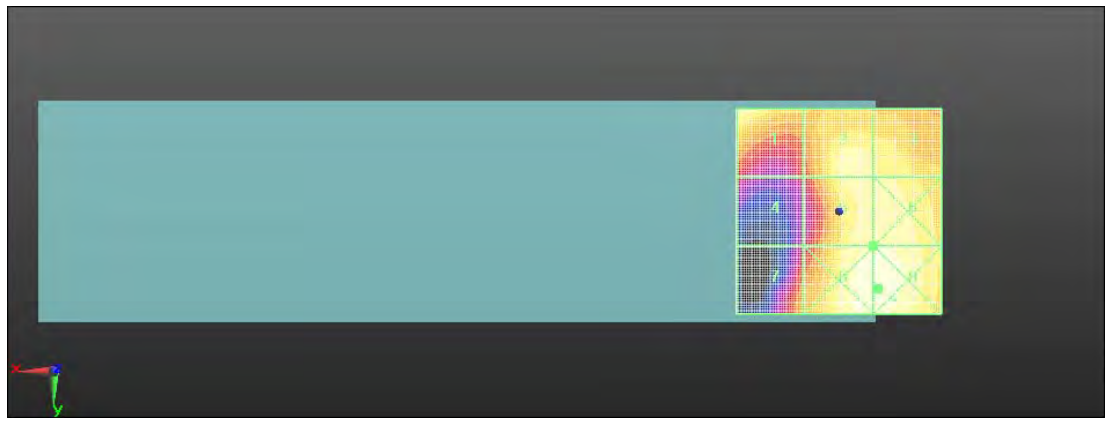
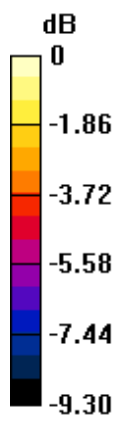
Grid 1 M4 23.67 dBV/m	Grid 2 M4 23.64 dBV/m	Grid 3 M4 23.3 dBV/m
Grid 4 M4 19.99 dBV/m	Grid 5 M4 23.82 dBV/m	Grid 6 M4 23.84 dBV/m
Grid 7 M4 21.67 dBV/m	Grid 8 M4 24.39 dBV/m	Grid 9 M4 24.41 dBV/m

Cursor:

Total = 24.41 dBV/m

E Category: M4

Location: -9.5, 19, 7.7 mm



0 dB = 16.61 V/m = 24.41 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC1 RC1 SO3 1175CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 1908.75 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 11.66 V/m; Power Drift = -0.13 dB

Applied MIF = 3.26 dB

RF audio interference level = 23.55 dBV/m

Emission category: M4

MIF scaled E-field

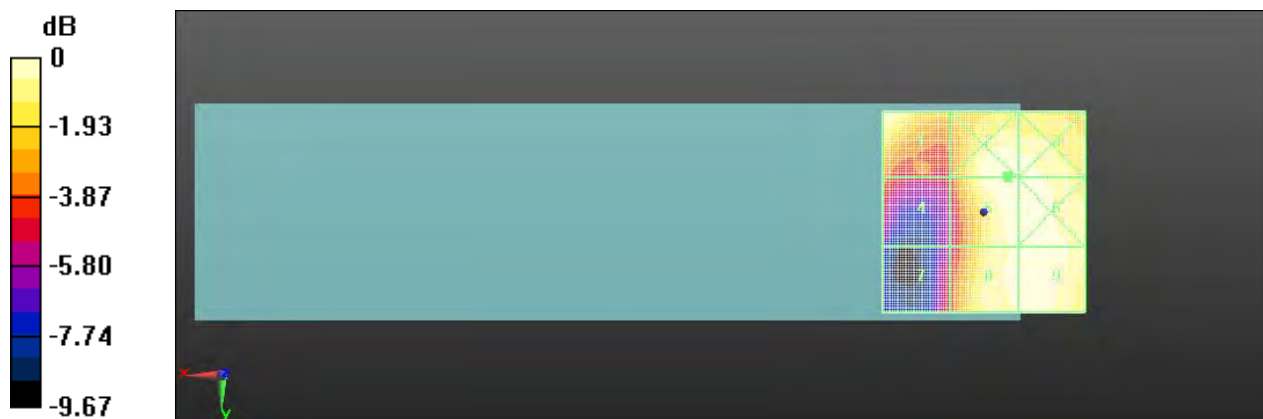
Grid 1 M4 23.43 dBV/m	Grid 2 M4 23.56 dBV/m	Grid 3 M4 23.4 dBV/m
Grid 4 M4 20.45 dBV/m	Grid 5 M4 23.55 dBV/m	Grid 6 M4 23.47 dBV/m
Grid 7 M4 19.22 dBV/m	Grid 8 M4 23.26 dBV/m	Grid 9 M4 23.46 dBV/m

Cursor:

Total = 23.56 dBV/m

E Category: M4

Location: -6, -9, 7.7 mm



Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC10 RC1 SO3 476CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 817.9 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.29 V/m; Power Drift = -0.07 dB

Applied MIF = 3.26 dB

RF audio interference level = 28.91 dBV/m

Emission category: M4

MIF scaled E-field

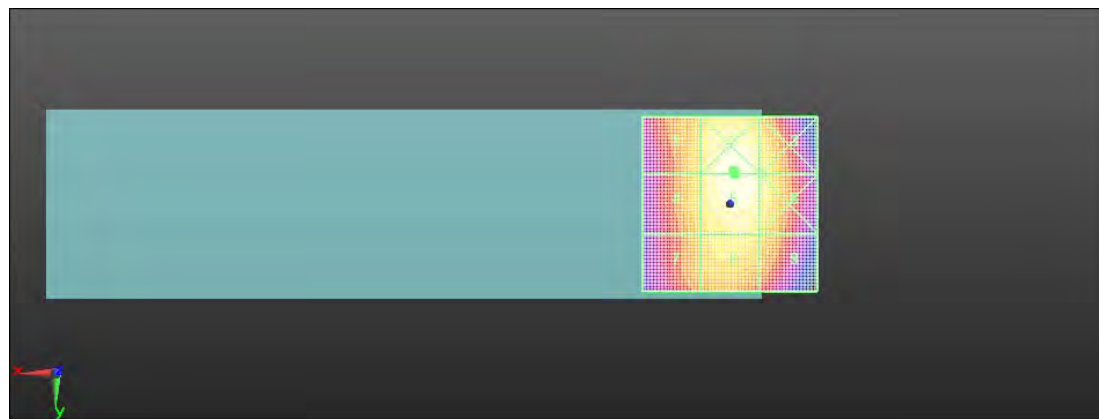
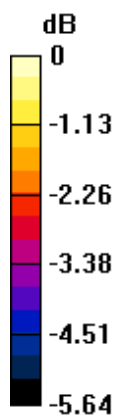
Grid 1 M4 27.86 dBV/m	Grid 2 M4 28.91 dBV/m	Grid 3 M4 28.37 dBV/m
Grid 4 M4 27.91 dBV/m	Grid 5 M4 28.91 dBV/m	Grid 6 M4 28.42 dBV/m
Grid 7 M4 27.54 dBV/m	Grid 8 M4 28.15 dBV/m	Grid 9 M4 27.74 dBV/m

Cursor:

Total = 28.91 dBV/m

E Category: M4

Location: -1, -9.5, 7.7 mm



0 dB = 27.90 V/m = 28.91 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC10 RC1 SO3 580CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 820.5 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.44 V/m; Power Drift = 0.00 dB

Applied MIF = 3.26 dB

RF audio interference level = 28.98 dBV/m

Emission category: M4

MIF scaled E-field

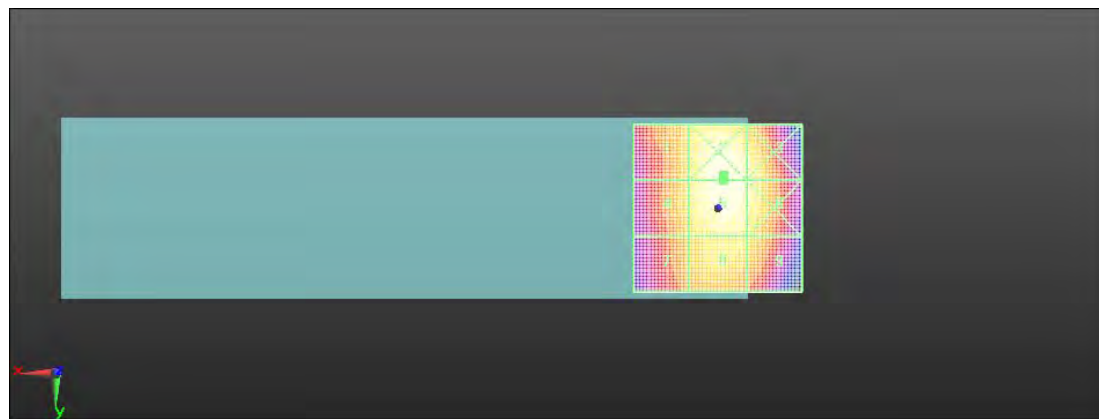
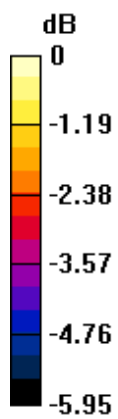
Grid 1 M4 27.9 dBV/m	Grid 2 M4 28.99 dBV/m	Grid 3 M4 28.52 dBV/m
Grid 4 M4 27.96 dBV/m	Grid 5 M4 28.98 dBV/m	Grid 6 M4 28.52 dBV/m
Grid 7 M4 27.52 dBV/m	Grid 8 M4 28.23 dBV/m	Grid 9 M4 27.93 dBV/m

Cursor:

Total = 28.99 dBV/m

E Category: M4

Location: -1.5, -10, 7.7 mm



0 dB = 28.17 V/m = 29.00 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-CDMA BC10 RC1 SO3 684CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10295 - AAB, CDMA2000, RC1, SO3, 1/8th Rate 25 fr.; Frequency: 823.1 MHz; Duty Cycle: 1:17.7419

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.65 V/m; Power Drift = 0.00 dB

Applied MIF = 3.26 dB

RF audio interference level = 28.97 dBV/m

Emission category: M4

MIF scaled E-field

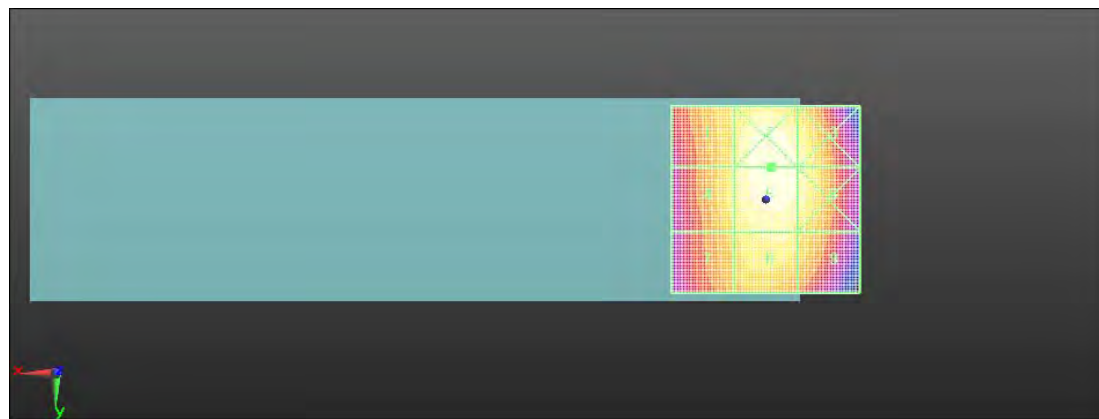
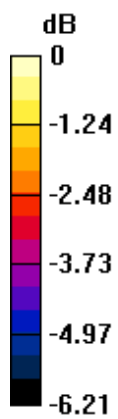
Grid 1 M4 27.93 dBV/m	Grid 2 M4 28.97 dBV/m	Grid 3 M4 28.5 dBV/m
Grid 4 M4 28 dBV/m	Grid 5 M4 28.97 dBV/m	Grid 6 M4 28.5 dBV/m
Grid 7 M4 27.65 dBV/m	Grid 8 M4 28.31 dBV/m	Grid 9 M4 27.93 dBV/m

Cursor:

Total = 28.97 dBV/m

E Category: M4

Location: -1.5, -8.5, 7.7 mm



0 dB = 28.08 V/m = 28.97 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC3 20M QPSK 1RB50 39750CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2506 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 10.86 V/m; Power Drift = -0.08 dB

Applied MIF = -1.62 dB

RF audio interference level = 17.81 dBV/m

Emission category: M4

MIF scaled E-field

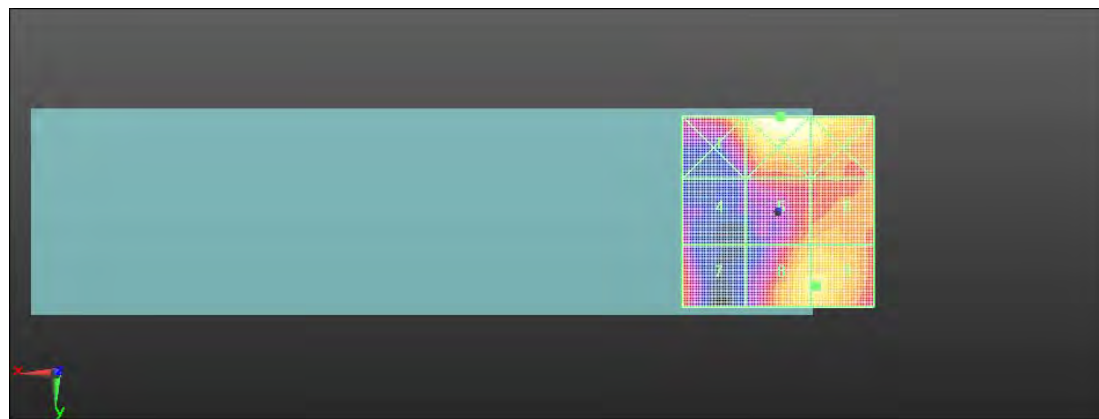
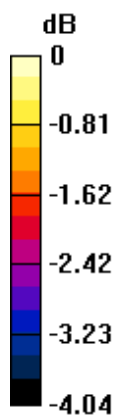
Grid 1 M4 17.64 dBV/m	Grid 2 M4 18.41 dBV/m	Grid 3 M4 18.03 dBV/m
Grid 4 M4 16.25 dBV/m	Grid 5 M4 17.13 dBV/m	Grid 6 M4 17.26 dBV/m
Grid 7 M4 17.07 dBV/m	Grid 8 M4 17.75 dBV/m	Grid 9 M4 17.81 dBV/m

Cursor:

Total = 18.41 dBV/m

E Category: M4

Location: -0.5, -25, 7.7 mm



0 dB = 8.323 V/m = 18.41 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC3 20M QPSK 1RB50 40185CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2549.5 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 14.11 V/m; Power Drift = 0.13 dB

Applied MIF = -1.62 dB

RF audio interference level = 19.89 dBV/m

Emission category: M4

MIF scaled E-field

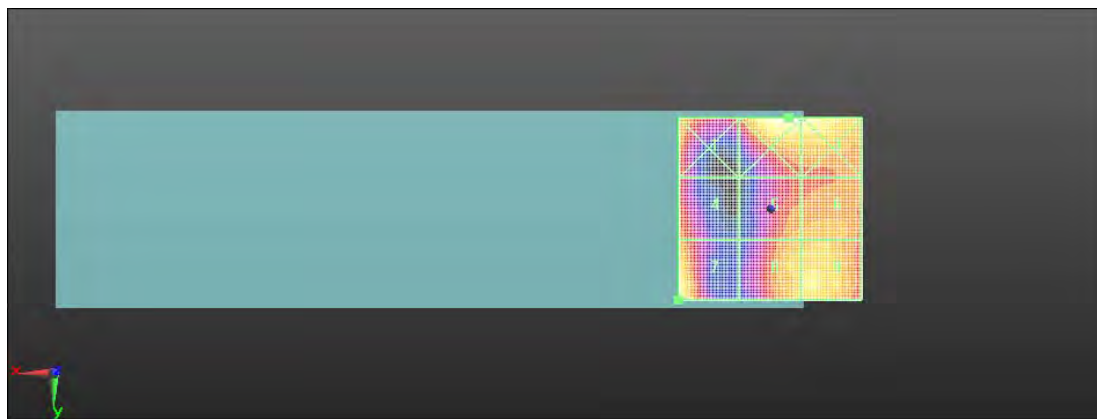
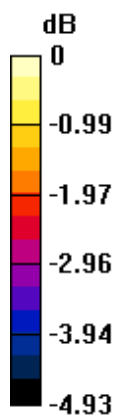
Grid 1 M4 19.01 dBV/m	Grid 2 M4 20.13 dBV/m	Grid 3 M4 19.86 dBV/m
Grid 4 M4 18.62 dBV/m	Grid 5 M4 18.68 dBV/m	Grid 6 M4 18.83 dBV/m
Grid 7 M4 19.89 dBV/m	Grid 8 M4 19.17 dBV/m	Grid 9 M4 19.3 dBV/m

Cursor:

Total = 20.13 dBV/m

E Category: M4

Location: -5, -25, 7.7 mm



0 dB = 10.15 V/m = 20.13 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC3 20M QPSK 1RB0 40620CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2593 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 13.15 V/m; Power Drift = -0.05 dB

Applied MIF = -1.62 dB

RF audio interference level = 19.56 dBV/m

Emission category: M4

MIF scaled E-field

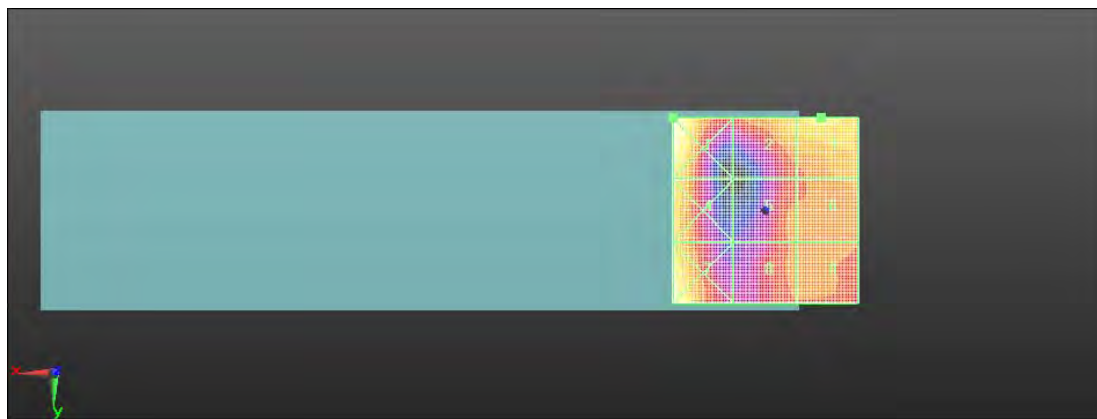
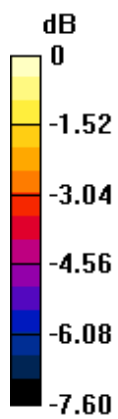
Grid 1 M4 20.8 dBV/m	Grid 2 M4 19.24 dBV/m	Grid 3 M4 19.56 dBV/m
Grid 4 M4 19.66 dBV/m	Grid 5 M4 18.04 dBV/m	Grid 6 M4 18.55 dBV/m
Grid 7 M4 20.53 dBV/m	Grid 8 M4 18.08 dBV/m	Grid 9 M4 18.26 dBV/m

Cursor:

Total = 20.80 dBV/m

E Category: M4

Location: 25, -25, 7.7 mm



0 dB = 10.96 V/m = 20.80 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC3 20M QPSK 1RB50 41055CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2636.5 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 12.93 V/m; Power Drift = 0.16 dB

Applied MIF = -1.62 dB

RF audio interference level = 19.95 dBV/m

Emission category: M4

MIF scaled E-field

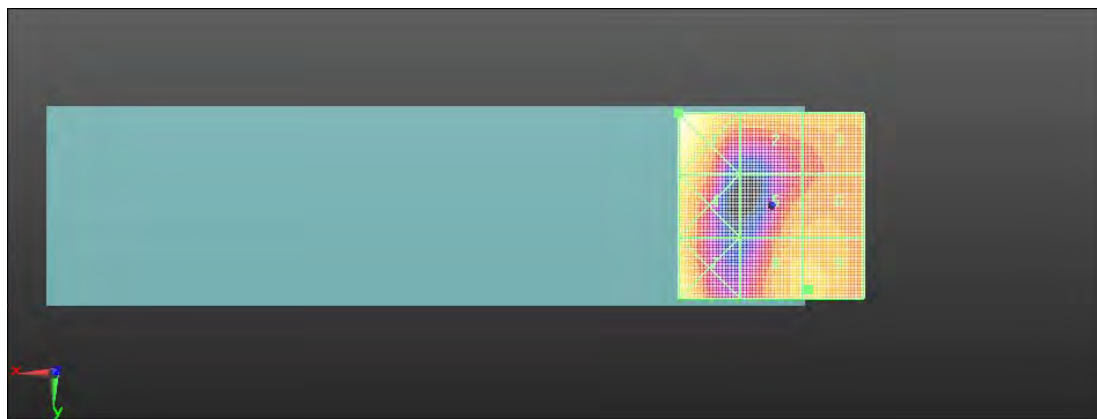
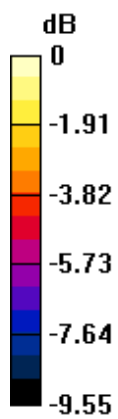
Grid 1 M4 22.3 dBV/m	Grid 2 M4 19.58 dBV/m	Grid 3 M4 19.46 dBV/m
Grid 4 M4 20.9 dBV/m	Grid 5 M4 19.3 dBV/m	Grid 6 M4 19.46 dBV/m
Grid 7 M4 21.22 dBV/m	Grid 8 M4 19.94 dBV/m	Grid 9 M4 19.95 dBV/m

Cursor:

Total = 22.30 dBV/m

E Category: M4

Location: 25, -25, 7.7 mm



0 dB = 13.03 V/m = 22.30 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC3 20M QPSK 1RB50 41490CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2680 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 12.07 V/m; Power Drift = -0.01 dB

Applied MIF = -1.62 dB

RF audio interference level = 20.66 dBV/m

Emission category: M4

MIF scaled E-field

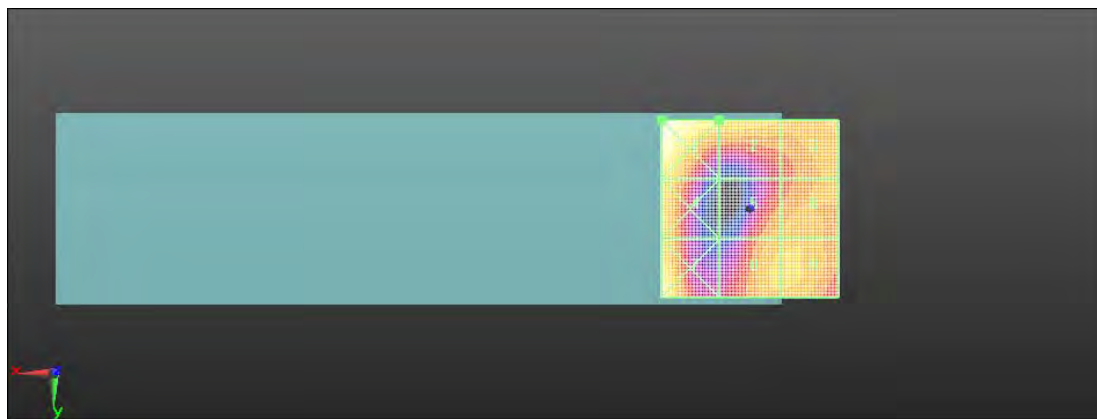
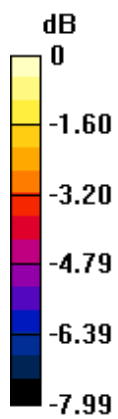
Grid 1 M4 22.01 dBV/m	Grid 2 M4 20.66 dBV/m	Grid 3 M4 20.01 dBV/m
Grid 4 M4 20.68 dBV/m	Grid 5 M4 19.62 dBV/m	Grid 6 M4 19.8 dBV/m
Grid 7 M4 21.43 dBV/m	Grid 8 M4 20.07 dBV/m	Grid 9 M4 20.09 dBV/m

Cursor:

Total = 22.01 dBV/m

E Category: M4

Location: 25, -25, 7.7 mm



0 dB = 12.60 V/m = 22.01 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC2 20M QPSK 1RB0 39750CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2506 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 13.83 V/m; Power Drift = -0.07 dB

Applied MIF = -1.62 dB

RF audio interference level = 18.53 dBV/m

Emission category: M4

MIF scaled E-field

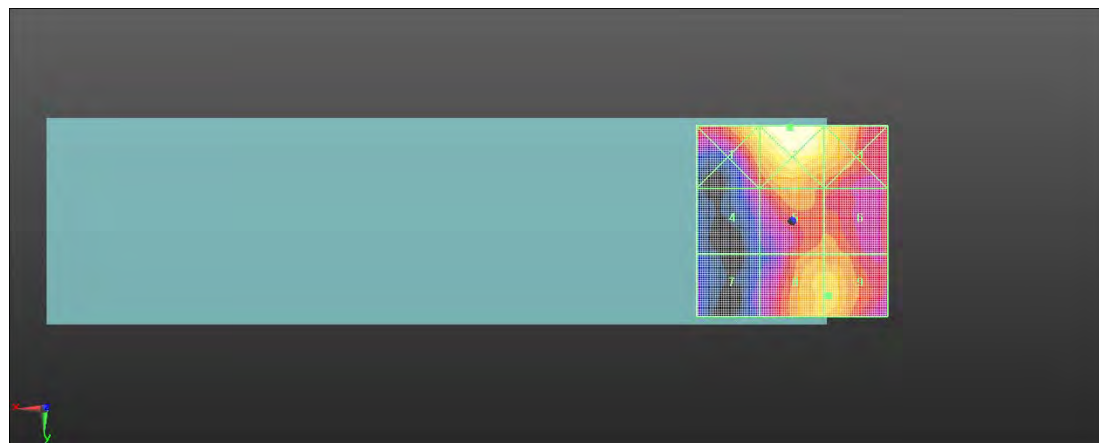
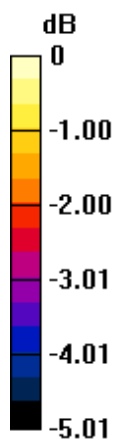
Grid 1 M4 18.99 dBV/m	Grid 2 M4 19.6 dBV/m	Grid 3 M4 18.8 dBV/m
Grid 4 M4 17 dBV/m	Grid 5 M4 17.99 dBV/m	Grid 6 M4 17.78 dBV/m
Grid 7 M4 16.49 dBV/m	Grid 8 M4 18.51 dBV/m	Grid 9 M4 18.53 dBV/m

Cursor:

Total = 19.60 dBV/m

E Category: M4

Location: 0.5, -24.5, 7.7 mm



0 dB = 9.546 V/m = 19.60 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC2 20M QPSK 1RB0 40185CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2549.5 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 17.40 V/m; Power Drift = -0.01 dB

Applied MIF = -1.62 dB

RF audio interference level = 20.69 dBV/m

Emission category: M4

MIF scaled E-field

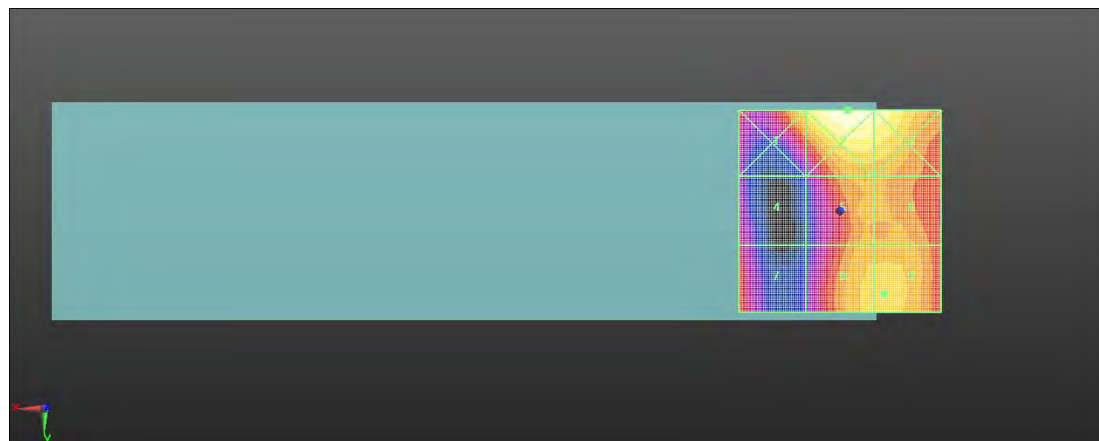
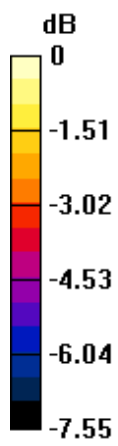
Grid 1 M4 21.06 dBV/m	Grid 2 M4 22.41 dBV/m	Grid 3 M4 22.03 dBV/m
Grid 4 M4 18.64 dBV/m	Grid 5 M4 20.12 dBV/m	Grid 6 M4 20.1 dBV/m
Grid 7 M4 19.61 dBV/m	Grid 8 M4 20.64 dBV/m	Grid 9 M4 20.69 dBV/m

Cursor:

Total = 22.41 dBV/m

E Category: M4

Location: -2, -25, 7.7 mm



0 dB = 13.19 V/m = 22.40 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC2 20M QPSK 1RB0 40620CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2593 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 17.50 V/m; Power Drift = 0.03 dB

Applied MIF = -1.62 dB

RF audio interference level = 20.52 dBV/m

Emission category: M4

MIF scaled E-field

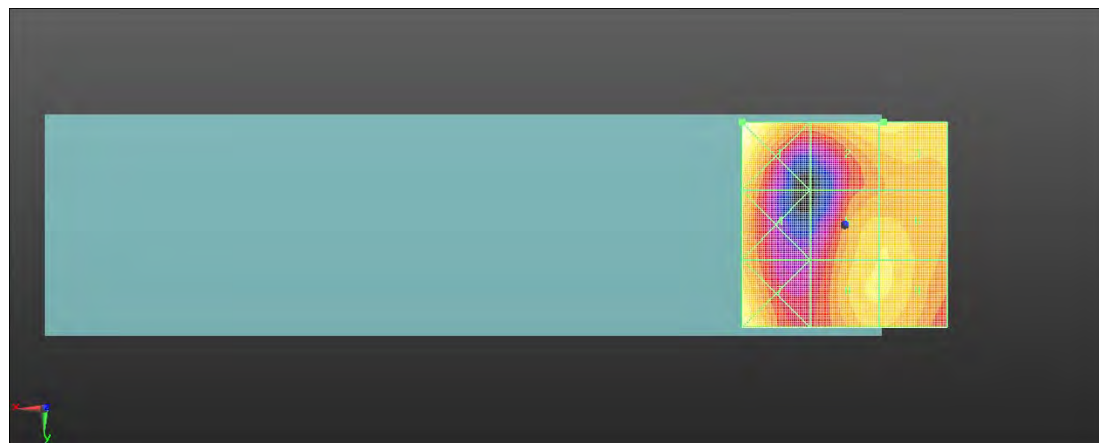
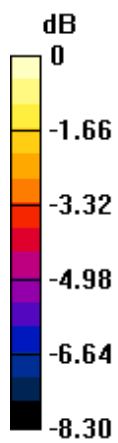
Grid 1 M4 21.97 dBV/m	Grid 2 M4 20.52 dBV/m	Grid 3 M4 20.52 dBV/m
Grid 4 M4 20.02 dBV/m	Grid 5 M4 20.34 dBV/m	Grid 6 M4 20.36 dBV/m
Grid 7 M4 21.42 dBV/m	Grid 8 M4 20.43 dBV/m	Grid 9 M4 20.43 dBV/m

Cursor:

Total = 21.97 dBV/m

E Category: M4

Location: 25, -25, 7.7 mm



0 dB = 12.55 V/m = 21.97 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC2 20M QPSK 1RB0 41055CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2636.5 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 16.88 V/m; Power Drift = 0.01 dB

Applied MIF = -1.62 dB

RF audio interference level = 22.51 dBV/m

Emission category: M4

MIF scaled E-field

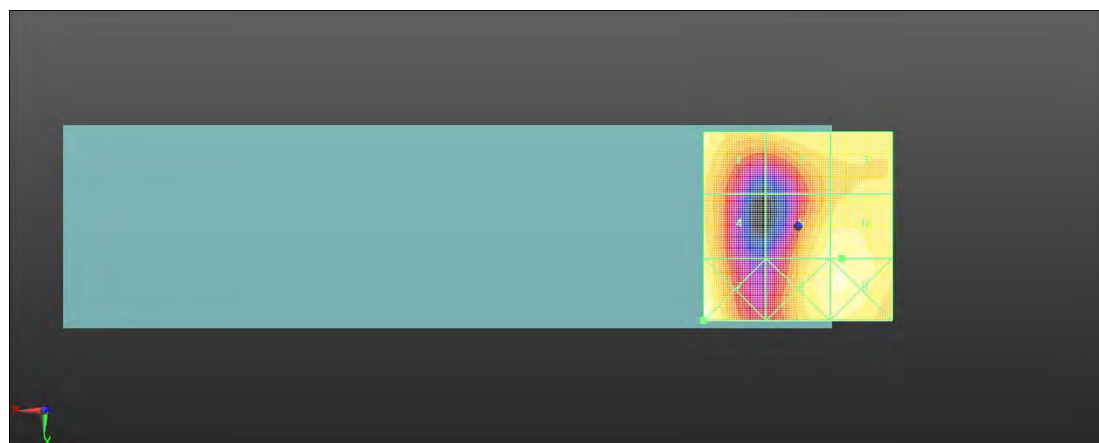
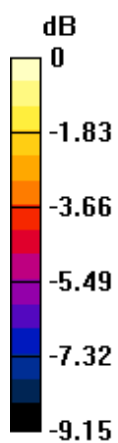
Grid 1 M4 22.25 dBV/m	Grid 2 M4 22.07 dBV/m	Grid 3 M4 21.95 dBV/m
Grid 4 M4 21.81 dBV/m	Grid 5 M4 22.34 dBV/m	Grid 6 M4 22.51 dBV/m
Grid 7 M4 23.21 dBV/m	Grid 8 M4 22.54 dBV/m	Grid 9 M4 22.69 dBV/m

Cursor:

Total = 23.21 dBV/m

E Category: M4

Location: 25, 25, 7.7 mm



0 dB = 14.47 V/m = 23.21 dBV/m

Test Laboratory: SGS-SAR Lab

FR150 HAC-RF-LTE Band 41 PC2 20M QPSK 1RB0 41490CH

DUT: FR150; Type: 4G Feature Phone; Serial: 354783970000025

Communication System: UID 10172 - CAG, LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK);
Frequency: 2680 MHz; Duty Cycle: 1:8.33681

Medium: Air; Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

DASY 5 Configuration:

- Probe: EF3DV3 - SN4051; ConvF(1, 1, 1); Calibrated: 2020-05-29;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn896; Calibrated: 2020-06-11
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Device E-Field measurement/E Scan - ER3D: 15 mm from Probe Center to the Device/Hearing Aid Compatibility Test (101x101x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 14.49 V/m; Power Drift = 0.19 dB

Applied MIF = -1.62 dB

RF audio interference level = 21.83 dBV/m

Emission category: M4

MIF scaled E-field

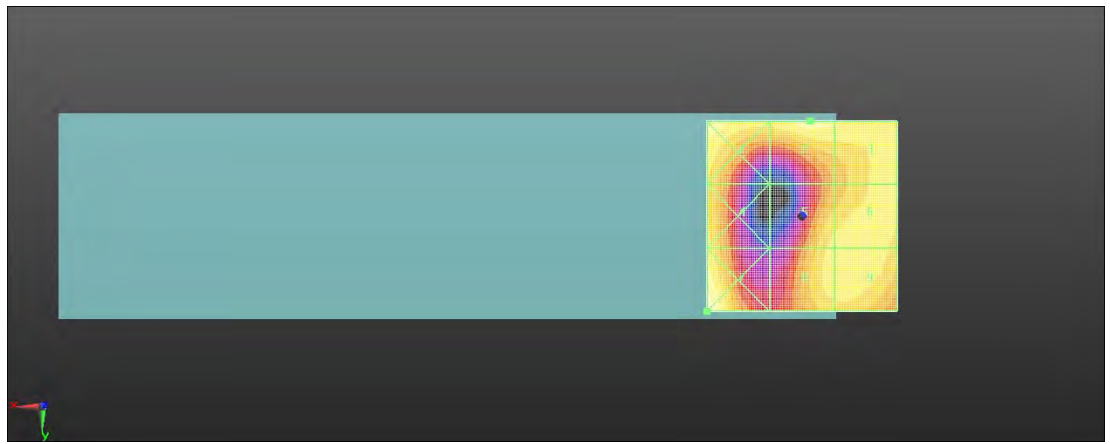
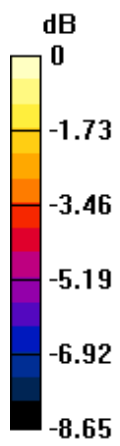
Grid 1 M4 21.91 dBV/m	Grid 2 M4 21.83 dBV/m	Grid 3 M4 21.59 dBV/m
Grid 4 M4 21.36 dBV/m	Grid 5 M4 21.17 dBV/m	Grid 6 M4 21.42 dBV/m
Grid 7 M4 22.65 dBV/m	Grid 8 M4 21.29 dBV/m	Grid 9 M4 21.47 dBV/m

Cursor:

Total = 22.65 dBV/m

E Category: M4

Location: 25, 25, 7.7 mm



0 dB = 13.57 V/m = 22.65 dBV/m



Appendix C

Calibration certificate

1. Dipole
CD835V3-SN 1052(2020-05-25)
CD1880V3-SN 1044(2020-05-25)
CD2600V3-SN 1021(2020-05-25)
2. DAE
DAE4-SN 896(2020-06-11)
3. Probe
EF3DV3-SN 4051(2020-05-29)



Accredited by the Swiss Accreditation Service (SAS)

Accreditation No.: **SCS 0108**

The Swiss Accreditation Service is one of the signatories to the EA
 Multilateral Agreement for the recognition of calibration certificates

Client **SGS-CN (Auden)**

Certificate No: **CD835V3-1052_May20**

CALIBRATION CERTIFICATE

Object **CD835V3 - SN: 1052**

Calibration procedure(s) **QA CAL-20.v7
 Calibration Procedure for Validation Sources in air**

Calibration date: **May 25, 2020**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
Type-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	31-Dec-19 (No. EF3-4013_Dec19)	Dec-20
Probe H3DV6	SN: 6065	31-Dec-19 (No. H3-6065_Dec19)	Dec-20
DAE4	SN: 781	27-Dec-19 (No. DAE4-781_Dec19)	Dec-20

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Jan-19)	In house check: Oct-20
Network Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-19)	In house check: Oct-20

	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: May 26, 2020

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Accreditation No.: **SCS 0108**

References

- [1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz $\pm$ 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	108.1 V/m = 40.68 dBV/m
Maximum measured above low end	100 mW input power	105.5 V/m = 40.47 dBV/m
Averaged maximum above arm	100 mW input power	106.8 V/m $\pm$ 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	15.6 dB	40.3 Ω - 11.6 j Ω
835 MHz	28.7 dB	51.9 Ω + 3.2 j Ω
880 MHz	17.4 dB	60.6 Ω - 10.7 j Ω
900 MHz	17.5 dB	52.0 Ω - 13.5 j Ω
945 MHz	22.6 dB	45.8 Ω + 5.8 j Ω

3.2 Antenna Design and Handling

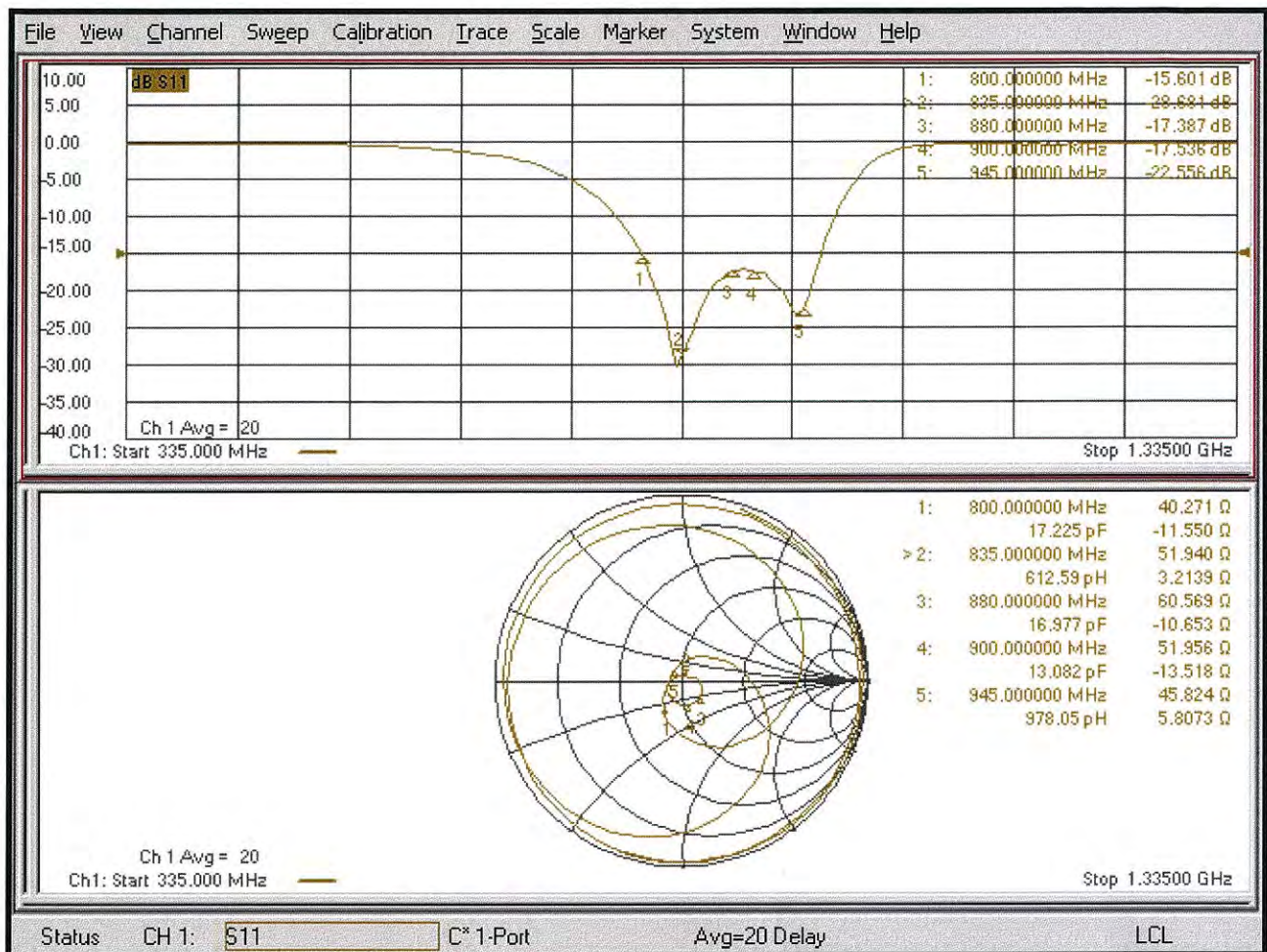
The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



DASY5 E-field Result

Date: 25.05.2020

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1052

Communication System: UID 0 - CW; Frequency: 835 MHz

Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 - SN4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 31.12.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 27.12.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 126.7 V/m; Power Drift = -0.02 dB

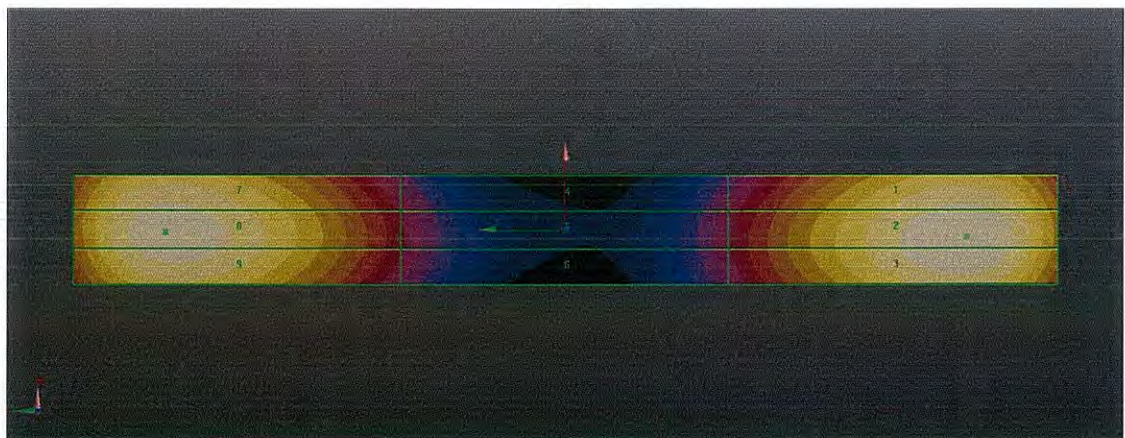
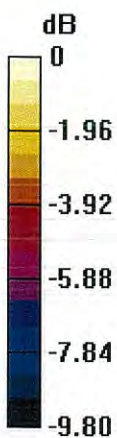
Applied MIF = 0.00 dB

RF audio interference level = 40.68 dBV/m

Emission category: M3

MIF scaled E-field

Grid 1 M3 40.24 dBV/m	Grid 2 M3 40.68 dBV/m	Grid 3 M3 40.64 dBV/m
Grid 4 M4 35.36 dBV/m	Grid 5 M4 35.62 dBV/m	Grid 6 M4 35.55 dBV/m
Grid 7 M3 40.21 dBV/m	Grid 8 M3 40.47 dBV/m	Grid 9 M3 40.36 dBV/m



0 dB = 108.1 V/m = 40.68 dBV/m



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Client **SGS-CN (Auden)**

Certificate No: **CD1880V3-1044_May20**

CALIBRATION CERTIFICATE

Object **CD1880V3 - SN: 1044**

Calibration procedure(s) **QA CAL-20.v7
Calibration Procedure for Validation Sources in air**

Calibration date: **May 25, 2020**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
Type-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	31-Dec-19 (No. EF3-4013_Dec19)	Dec-20
Probe H3DV6	SN: 6065	31-Dec-19 (No. H3-6065_Dec19)	Dec-20
DAE4	SN: 781	27-Dec-19 (No. DAE4-781_Dec19)	Dec-20
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Jan-19)	In house check: Oct-20
Network Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-19)	In house check: Oct-20

	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	

	Name	Function	Signature
Approved by:	Katja Pokovic	Technical Manager	

Issued: May 26, 2020

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Accreditation No.: **SCS 0108**

References

- [1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz $\pm$ 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	87.8 V/m = 38.87 dBV/m
Maximum measured above low end	100 mW input power	86.0 V/m = 38.69 dBV/m
Averaged maximum above arm	100 mW input power	86.9 V/m $\pm$ 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
1730 MHz	24.0 dB	54.1 Ω + 5.1 j Ω
1880 MHz	19.7 dB	59.2 Ω + 6.5 j Ω
1900 MHz	20.4 dB	60.1 Ω + 3.0 j Ω
1950 MHz	27.2 dB	53.0 Ω - 3.3 j Ω
2000 MHz	21.4 dB	45.4 Ω + 6.8 j Ω

3.2 Antenna Design and Handling

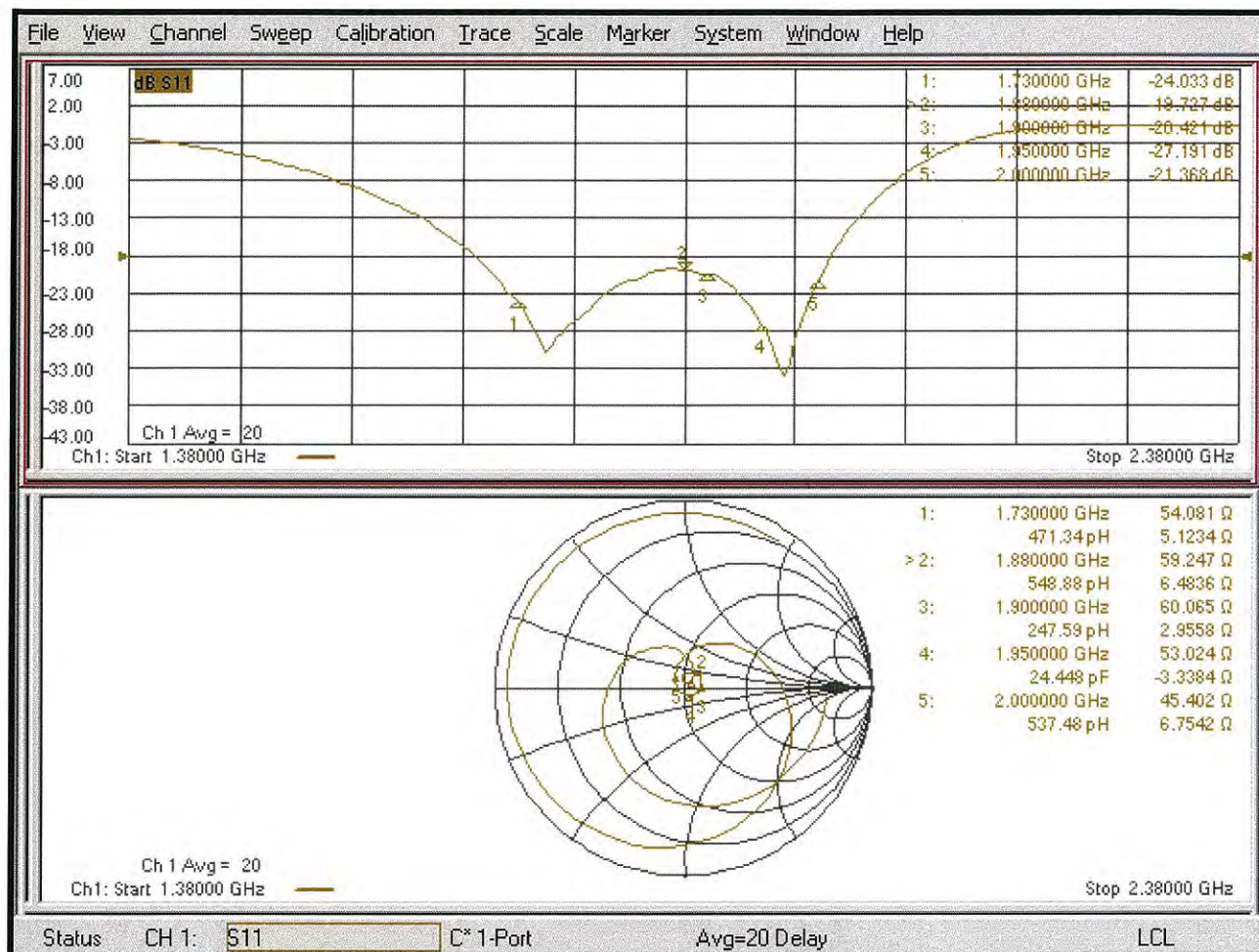
The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



DASY5 E-field Result

Date: 25.05.2020

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1044

Communication System: UID 0 - CW; Frequency: 1880 MHz

Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 - SN4013; ConvF(1, 1, 1) @ 1880 MHz; Calibrated: 31.12.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 27.12.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 151.5 V/m; Power Drift = -0.02 dB

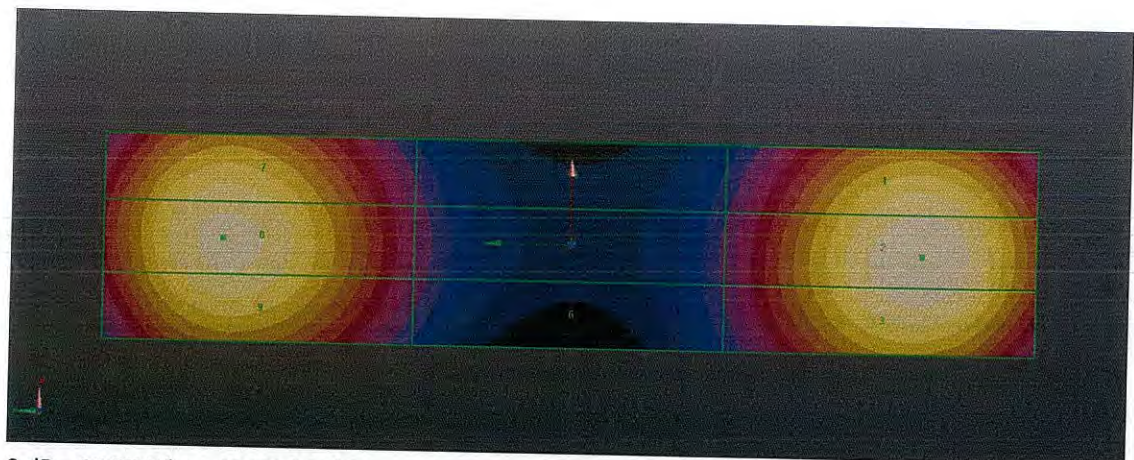
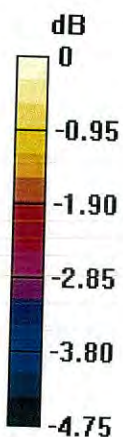
Applied MIF = 0.00 dB

RF audio interference level = 38.87 dBV/m

Emission category: M2

MIF scaled E-field

Grid 1 M2 38.59 dBV/m	Grid 2 M2 38.87 dBV/m	Grid 3 M2 38.77 dBV/m
Grid 4 M2 35.89 dBV/m	Grid 5 M2 36.02 dBV/m	Grid 6 M2 35.96 dBV/m
Grid 7 M2 38.46 dBV/m	Grid 8 M2 38.69 dBV/m	Grid 9 M2 38.53 dBV/m



0 dB = 87.77 V/m = 38.87 dBV/m



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Client **SGS-CN (Auden)**

Certificate No: **CD2600V3-1021_May20**

CALIBRATION CERTIFICATE

Object **CD2600V3 - SN: 1021**

Calibration procedure(s) **QA CAL-20.v7
 Calibration Procedure for Validation Sources in air**

Calibration date: **May 25, 2020**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
Type-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	31-Dec-19 (No. EF3-4013_Dec19)	Dec-20
Probe H3DV6	SN: 6065	31-Dec-19 (No. H3-6065_Dec19)	Dec-20
DAE4	SN: 781	27-Dec-19 (No. DAE4-781_Dec19)	Dec-20

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-17)	In house check: Oct-20
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-17)	In house check: Oct-20
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Jan-19)	In house check: Oct-20
Network Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-19)	In house check: Oct-20

	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: May 26, 2020

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References

- [1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	2600 MHz $\pm$ 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 2600 MHz

E-field 15 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	84.3 V/m = 38.52 dBV/m
Maximum measured above low end	100 mW input power	82.8 V/m = 38.36 dBV/m
Averaged maximum above arm	100 mW input power	83.5 V/m $\pm$ 12.8 % (k=2)

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
2450 MHz	18.3 dB	42.4 Ω - 8.3 j Ω
2550 MHz	28.4 dB	46.7 Ω + 1.7 j Ω
2600 MHz	34.5 dB	49.8 Ω + 1.9 j Ω
2650 MHz	30.6 dB	53.0 Ω + 0.5 j Ω
2750 MHz	18.4 dB	51.2 Ω - 12.2 j Ω

3.2 Antenna Design and Handling

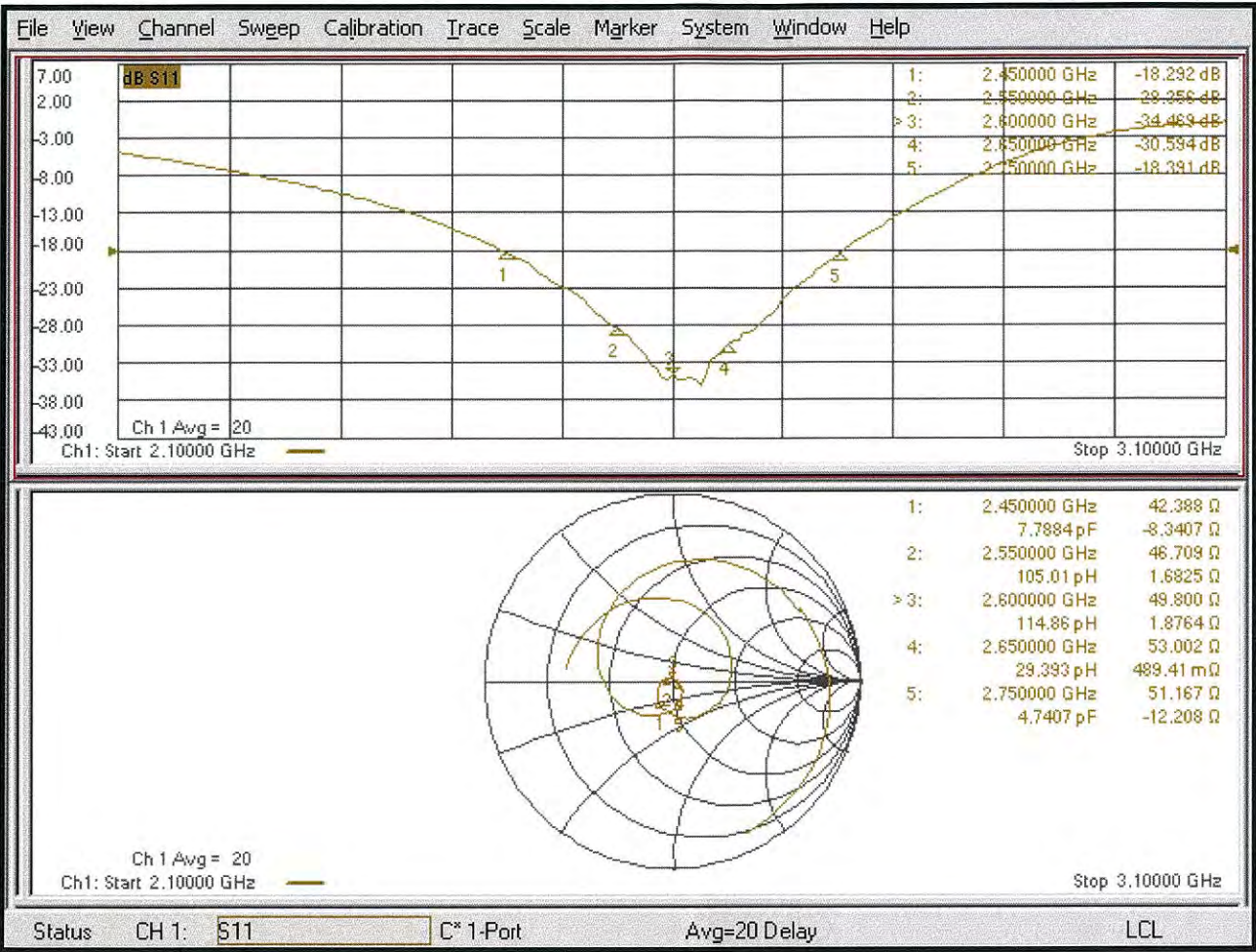
The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



DASY5 E-field Result

Date: 25.05.2020

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2600 MHz; Type: CD2600V3; Serial: CD2600V3 - SN: 1021

Communication System: UID 0 - CW; Frequency: 2600 MHz

Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 0$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 - SN4013; ConvF(1, 1, 1) @ 2600 MHz; Calibrated: 31.12.2019
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 27.12.2019
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 2600MHz/E-Scan - 2600MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 66.37 V/m; Power Drift = 0.01 dB

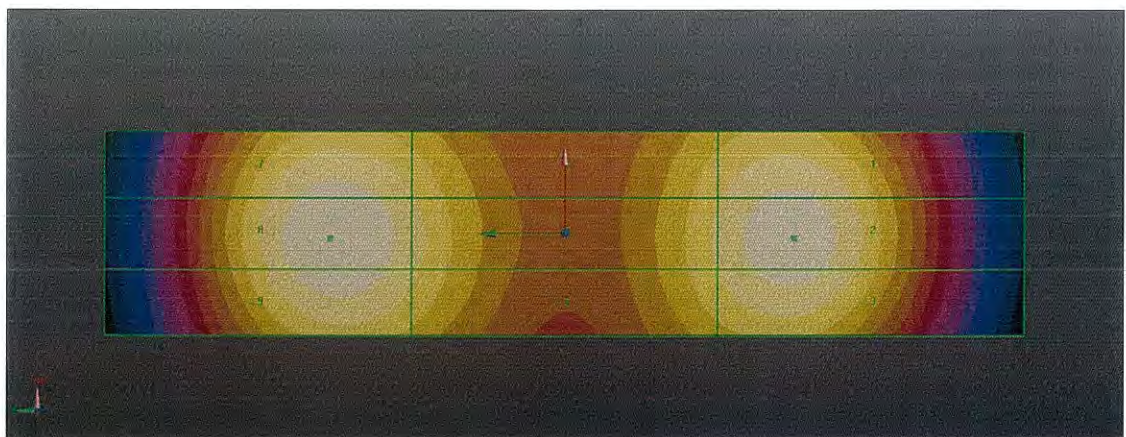
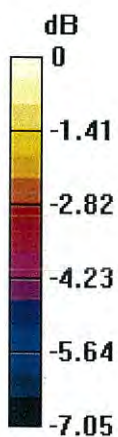
Applied MIF = 0.00 dB

RF audio interference level = 38.52 dBV/m

Emission category: M2

MIF scaled E-field

Grid 1 M2 38.15 dBV/m	Grid 2 M2 38.36 dBV/m	Grid 3 M2 38.22 dBV/m
Grid 4 M2 37.61 dBV/m	Grid 5 M2 37.8 dBV/m	Grid 6 M2 37.72 dBV/m
Grid 7 M2 38.27 dBV/m	Grid 8 M2 38.52 dBV/m	Grid 9 M2 38.37 dBV/m



0 dB = 84.31 V/m = 38.52 dBV/m

IMPORTANT NOTICE

USAGE OF THE DAE4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is fixed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **SGS-CN (Auden)**

Certificate No: **DAE4-896_Jun20**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 896**

Calibration procedure(s) **QA CAL-06.v30**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **June 11, 2020**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	03-Sep-19 (No:25949)	Sep-20
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	09-Jan-20 (in house check)	In house check: Jan-21
Calibrator Box V2.1	SE UMS 006 AA 1002	09-Jan-20 (in house check)	In house check: Jan-21

Calibrated by:	Name	Function	Signature
	Eric Hainfeld	Laboratory Technician	
Approved by:	Sven Kühn	Deputy Manager	

Issued: June 11, 2020

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Accreditation No.: **SCS 0108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.020 $\pm$ 0.02% (k=2)	404.270 $\pm$ 0.02% (k=2)	404.201 $\pm$ 0.02% (k=2)
Low Range	3.98028 $\pm$ 1.50% (k=2)	3.99643 $\pm$ 1.50% (k=2)	3.97192 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	37.5 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	200031.72	-0.85	-0.00
Channel X	+ Input	20003.84	-1.17	-0.01
Channel X	- Input	-20002.90	3.17	-0.02
Channel Y	+ Input	200032.22	-0.65	-0.00
Channel Y	+ Input	20002.66	-2.27	-0.01
Channel Y	- Input	-20005.59	0.56	-0.00
Channel Z	+ Input	200031.62	-1.12	-0.00
Channel Z	+ Input	20001.63	-3.29	-0.02
Channel Z	- Input	-20006.11	0.11	-0.00

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2000.46	-0.47	-0.02
Channel X	+ Input	201.01	0.15	0.07
Channel X	- Input	-198.83	0.16	-0.08
Channel Y	+ Input	2000.11	-0.61	-0.03
Channel Y	+ Input	199.03	-1.65	-0.82
Channel Y	- Input	-200.32	-1.15	0.57
Channel Z	+ Input	2000.58	-0.14	-0.01
Channel Z	+ Input	199.41	-1.29	-0.64
Channel Z	- Input	-200.10	-0.86	0.43

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	12.27	10.72
	- 200	-9.94	-11.49
Channel Y	200	16.61	16.02
	- 200	-17.95	-18.85
Channel Z	200	5.05	5.08
	- 200	-6.58	-6.77

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-1.55	-4.57
Channel Y	200	6.73	-	0.61
Channel Z	200	9.49	4.63	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15563	17646
Channel Y	15995	17799
Channel Z	15649	15511

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.76	-0.05	2.07	0.40
Channel Y	-0.98	-2.24	0.08	0.48
Channel Z	-0.72	-1.67	0.77	0.37

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: **SCS 0108**

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Client **SGS-CN (Auden)**

Certificate No: **EF3-4051_May20**

CALIBRATION CERTIFICATE

Object **EF3DV3- SN:4051**

Calibration procedure(s) **QA CAL-02.v9, QA CAL-25.v7**
 Calibration procedure for E-field probes optimized for close near field
 evaluations in air

Calibration date: **May 29, 2020**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: CC2552 (20x)	31-Mar-20 (No. 217-03106)	Apr-21
DAE4	SN: 789	27-Dec-19 (No. DAE4-789_Dec19)	Dec-20
Reference Probe ER3DV6	SN: 2328	05-Oct-19 (No. ER3-2328_Oct19)	Oct-20
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-18)	In house check: Jun-20
Network Analyzer E8358A	SN: US41080477	31-Mar-14 (in house check Oct-19)	In house check: Oct-20

	Name	Function	Signature
Calibrated by:	Michael Weber	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	
Issued: June 1, 2020			
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			



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Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
E _n	incident E-field orientation normal to probe axis
E _p	incident E-field orientation parallel to probe axis
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart).
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4051

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V/m})^2$)	0.63	0.49	1.31	$\pm 10.1 \%$
DCP (mV) ^B	100.9	97.5	97.9	

Calibration results for Frequency Response (30 MHz – 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.2	77.4	0.2%	77.5	0.3%	$\pm 5.1 \%$
100	77.3	78.1	1.0%	77.8	0.6%	$\pm 5.1 \%$
450	77.1	78.0	1.1%	77.9	1.0%	$\pm 5.1 \%$
600	77.2	77.6	0.6%	77.5	0.5%	$\pm 5.1 \%$
750	77.3	77.4	0.2%	77.2	0.0%	$\pm 5.1 \%$
1800	140.3	139.4	-2.6%	139.2	-2.8%	$\pm 5.1 \%$
2000	133.0	131.5	-2.6%	131.3	-2.8%	$\pm 5.1 \%$
2200	125.1	123.5	-3.2%	124.3	-2.5%	$\pm 5.1 \%$
2500	123.7	122.5	-2.4%	123.3	-1.7%	$\pm 5.1 \%$
3000	78.9	75.8	-4.4%	76.8	-3.2%	$\pm 5.1 \%$
3500	250.5	249.2	-3.0%	245.7	-4.3%	$\pm 5.1 \%$
3700	244.2	240.4	-3.6%	238.9	-4.2%	$\pm 5.1 \%$
5200	50.8	51.3	1.1%	51.8	2.0%	$\pm 5.1 \%$
5500	49.7	49.4	-0.6%	48.3	-2.8%	$\pm 5.1 \%$
5800	48.9	48.5	-0.6%	49.8	1.9%	$\pm 5.1 \%$

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.